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# NASA TECHNICAL MEMORANDUM

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CHARACTERIZATION OF THREE TYPES OF SILICON SOLAR CELLS FOR SEPS DEEP SPACE MISSIONS

Volume I. Current-Voltage Characteristics of OCLI BSF/BSR 10 ohm-cm, BSR 10 ohm-cm, and BSR 2 ohm-cm Cells as a Function of Temperature and Intensity

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### TABLE OF CONTENTS

		Page
I.	INTRODUCTION	1
II.	TEST PROGRAM	1
	A. Solar Cell Descriptions B. Test Profile C. Test Equipment	1 2 2
III.	PRESENTATION OF TEST RESULTS	3
	A. General Features  B. BSF/BSR 10 ohm-cm Silicon Cell  C. BSR 10 ohm-cm Silicon Cells  D. BSR 2 ohm-cm Silicon Cells	3 4 4 5
IV.	DISCUSSION OF RESULTS	5
	A. General Features	5
	ohm-em to BSR 10 ohm-em	6
	ohm-em to BSR 2 ohm-em	7
	I-V Data	7
V.	SUMMARY	9
REFE	RENCES	83
OT OU	77 CT A 17	0.4

## LIST OF ILLUSTRATIONS

Figure	Title	Page
1.	Solar cell test plate	12
2.	Solar cell characterization equipment and instrumentation	13
3.	Dark current versus bins voltage for a good cell	15
4.	Dark current versus bias voltage for a bad cell	16
	BSF/BSR 10 ohm-cm	
5.	Average I as a function of temperature	20
6.	Average I as a function of intensity	21
7.	Average Voc as a function of temperature	22
8.	Average V <sub>oc</sub> as a function of intensity	23
9.	Average I as a function of temperature	24
10.	Average Imp as a function of intensity	25
11.	Average V <sub>mp</sub> as a function of temperature	26
12.	Average V <sub>mp</sub> as a function of intensity	27
13.	Average MP as a function of temperature	28
14.	Average MP as a function of intensity	29
15.	Average efficiency as a function of temperature	30
16.	Average efficiency as a function of intensity	31
17.	Efficiency of the best/worst cells as a function of temperature	32
18.	Efficiency of the best/worst cells as a function of intensity	33
	BSR 10 ohm-cm	
19.	Average I as a function of temperature	40
20.	Average I as a function of intensity	41

## LIST OF ILLUSTRATIONS (Continued)

Figure	Title	Page
21.	Average Voe as a function of temperature	42
22.	Average V <sub>oe</sub> as a function of intensity	43
23.	Average Imp as a function of temperature	44
24.	Average 1 as a function of intensity	45
25.	Average V <sub>mp</sub> as a function of temperature	46
26,	Average V <sub>mp</sub> as a function of intensity	47
27.	Average MP as a function of temperature	48
28.	Average MP as a function of intensity	49
29.	Average efficiency as a function of temperature	50
30.	Average efficiency as a function of intensity	51
31.	Efficiency of the best/worst cells as a function of temperature	52
32.	Efficiency of the best/worst cells as a function of intensity	53
	BSR 2 ohm-em	
33.	Average I <sub>se</sub> as a function of temperature	60
34.	Average I <sub>se</sub> as a function of intensity	61
35.	Average V <sub>oe</sub> as a function of temperature	62
36.	Average V <sub>oe</sub> as a function of intensity	63
37.	Average Imp as a function of temperature	64
38.	Average Imp as a function of intensity	65
39.	Average V <sub>mp</sub> as a function of temperature	66
40.	Average V <sub>mp</sub> as a function of intensity	67
41.	Average MP as a function of temperature	ß

## LIST OF ILLUSTRATIONS (Concluded)

Figure	Title	Pago
42.	Average MP as a function of intensity	69
43.	Average efficiency as a function of temperature	70
44.	Average efficiency as a function of intensity	71
45.	Efficiency of the best/worst cells as a function of temperature	72
46.	Efficiency of the best/worst cells as a function of intensity	73
47.	Simplified equivalent circuit of a silicon solar cell	80
48.	P/Po as a function of heliocentric distance	81
49.	Solar array temperature versus AU	82

## LIST OF TABLES

Table	Title	Page
1.	Test Cell Descriptions	10
2.	Test Profile	11
3.	Equivalent Circuit Resistances of Selected Individual Silicon Solar Cells	14
4.	Current-Voltage Paremeters of the Best Cells	17
5.	Fill Factors for All Cells	18
	USF/BSR 10 ohm-em	
6.	Average Jsc (mA)	34
7.	Average V <sub>oc</sub> (mV)	35
8.	Average Imp (mA)	36
9.	Average V <sub>mp</sub> (mV)	37
10.	Average MP (mW)	38
11.	Average Efficiency (%)	39
	BSR 10 ohm-em	
12.	Average I <sub>sc</sub> (mA)	54
13.	Average V <sub>oe</sub> (mV)	55
14.	Average Imp (mA)	56
15.	Average V <sub>mp</sub> (mV)	57
16.	Average MP (mW)	58
17.	Average Efficiency (%)	59
	BSR 2 ohm-em	
18.	Average I (mA)	74
19.	Average V <sub>ac</sub> (mV)	75

## LIST OF TABLES (Concluded)

Table	Title	Page
20.	Average I <sub>mp</sub> (mA)	76
21.	Average Imp (mV)	77
22.	Average MP (mW)	78
23.	Average Efficiency (%)	79

#### TECHNICAL MEMORANDUM

# CHARACTERIZATION OF THREE TYPES OF SILICON SOLAR CELLS FOR SEPS DEEP SPACE MISSIONS

Volume I. Current-Voltage Characteristics of OCLI BSF/BSR 10 ohm-cm, BSR 10 ohm-cm, and BSR 2 ohm-cm Cells as a Function of Temperature and Intensity

#### I. INTRODUCTION

This is the first in a series of technical reports on the characterization of high performance solar cells under conditions of low temperatures and low intensities. Today's solar cells have been designed for maximum performance at 1 AU\*, AMO, with little regard for the characteristics that would enhance their performance in deep space. In the late 1960's and early 1970's, data were generated on a few solar cells under Jupiter mission conditions; however, little has been produced since that time. The interest in solar cell performance under deep space conditions has been renewed as a result of the SEPS Halley Comet Flyby and Tempel 2 Mission. These data generated in support of the SEPS program are aimed at identifying which of the currently available cells possess the best characteristics for deep space performance. This report contains data on three types of cells taken at 9 intensities and 10 temperatures identified along the SEPS Mission profile. Graphs and tables together with interpretive conclusions are presented for the three types of cells.

#### II. TEST PROGRAM

#### A. Solar Cell Descriptions

Three types of cells (BSF/BSR 10 ohm-cm, BSR 10 ohm-cm, and BSR 2 ohm-cm) from Optical Coating Laboratories, Inc. (OCLI), described in Table 1, were selected to compare, under conditions of low temperature and low intensity, the performance of the BSF/BSR configured cells to that of the BSR configured cells and the performance of the 10 ohm-cm base resistivity cells to the 2 ohm-cm base resistivity cells. The silicon utilized in the manufacture of these cells was Czochralski produced (high oxygen content) and boron doped.

<sup>\*</sup> For this and other aeronyms see glossary.

#### B. Test Profile

The test profile for the evaluation of these cells is shown in Table 2. These temperature/intensity values were selected from the SEPS Halley Comet Flyby-Tempel 2 mission environment. In addition to the I-V data taken at various temperatures and intensities, dark I-V data were taken at nine temperatures.

#### C. Test Equipment

The cells were mounted to a copper plate using RTV 560. Each test set consisted of 16 cells; one set is shown mounted in Figure 1. The copper plate was then heat sunk to a plate configured for cooling with liquid nitrogen and for heating with hot air. The copper plate and two cells were thermocoupled and temperatures monitored continually. Cell temperatures were maintained independent of the incident solar intensity to within ±0.5°C from 50° to -175°C. The cells were installed in a vacuum system having a 30-cm diameter, 6 mm thick UV grade fused quartz window and tested at a pressure of 1 × 10<sup>-4</sup> pascal or less.

The illumination source was a Spectrolab filtered X-75 solar simulator. This system provides a combined beam from three 2.5 kW xenon lamps covering an area of 230 cm<sup>2</sup>. Beam intensity was measured at each cell position and was determined to have a uniformity of ±2 percent. The spectral output was modified through the use of a filter system to approximate the solar spectrum. Illumination levels were maintained through the use of a set of neutral density filters and by varying the position of the test chamber. Cell illumination level was monitored through the use of a water-cooled calibrated cell maintained at 28°C ± 0.5°C. One solar constant utilized in the calibration was 135.3 mW/cm<sup>2</sup>.

A Spectrolab electronic load model D-1550 provided the variable load for the cells. The cell I-V curves were plotted on an X-Y recorder. Digital voltmeters were used to read the open circuit voltages and short circuit currents. All instruments were calibrated prior to the initiation of these tests. The test setup with associated instrumentation is shown in Figure 2.

The value of the dark current produced through each individual cell by dc forward bias voltage was recorded at each temperature from zero bias to a current of at least 10 mA. These dark I-V curves were analyzed in terms of equivalent circuit models for the solar cells. Preliminary model calculations for selected cells from each set are discussed below. The dark I-V data shown in Table 3 for the best and worst cells of each set have been transcribed from the linear scales of the X-Y recorder to the log I versus linear V scales shown.

#### III. PRESENTATION OF TEST RESULTS

Current-voltage characteristics for each of three sets of 16 silicon solar cells supplied by OCLI have been measured. The mean values of each set observed at each operating condition (temperature and light intensity), together with observed standard deviations and mean efficiencies, are presented in both tables and graphs. The graphs are plotted from the data presented in the tables. The behavior of the individual best and worst cells of each set, selected on the basis of maximum power output at 0.086 solar constant (SC)/=100°C (where the SEPS will spend considerable time), is described by graphs of their efficiency versus light intensity and temperature and graphs of their dark current versus forward bias (dark I-V) at 25°C and at =150°C. Table 3 presents preliminary model calculations from the dark I-V data for these best and worst cells.

Examples of the dark current versus forward bias for "best" and "worst" cells are presented in Figures 3 and 4, respectively. Current-voltage parameters of the best cell of each set selected on the basi, of its maximum power output at 0.086 SC and at -100°C are shown in Table 4. Fill factors which show data scatter within each group are given in Table 5 for three test conditions.

#### A. General Features

The response of these sets of solar cells to simulated solar illumination and to various temperatures is found to have the following general features:

- 1) Short circuit current, I<sub>sc</sub>, is directly proportional to input light intensity. The proportionality constant being nearly independent of temperature is a feature of good cell design.
- 2) Open circuit voltage,  $V_{\rm oc}$ , increases linearly as cell temperature is lowered, with the slope being nearly independent of light flux. The absolute value of  $V_{\rm oc}$  drops with increasing light intensity by approximately 50 percent from 0.040 to 1.0 SC.
- 3) Maximum power, MP, is directly proportional to the incident intensity at each temperature, with a monotonic decrease of the proportionality constant with increasing temperature.
- a) Efficiency at maximum power output decreases steadily with increasing temperature, the mean value dropping approximately by a factor of 2 from -150°C to +50°C. This feature is independent of light intensity above 0.08 SC as expected from the close correlation in high performance cells between the maximum power conditions with the open circuit voltage and short circuit current features.

- b) Maximum power current, I<sub>mp</sub>, is directly proportional to light intensity and essentially independent of temperature. This feature is closely related to that of the short circuit current in these high performance cells.
- c) Maximum power voltage,  $V_{mp}$ , decreases linearly with increasing cell temperature, independent of light intensity above 0.08 SC. This linear decrease feature is closely related to that of the open circuit voltage in these high performance cells.
- 4) Scatter of measured values within each of the sets of 16 cells is indicated by the standard deviation values in the tables. Another measure of the scatter within each set is given by the fill factors at three test conditions and by discussion of a few individual cells, selected as having the best and the worst maximum power output at 0.086 SC and -100°C.

#### B. BSF/BSR 10 chm-cm Silicon Cell

I<sub>se</sub>, V<sub>oe</sub>, I<sub>mp</sub>, V<sub>mp</sub>, and MP are plotted as functions of temperature and intensity in Figures 5 through 14. Average values with standard deviations are summarized in Tables 6 through 10. Cell efficiencies are plotted as functions of temperature and intensity in Figures 15 and 16 and summarized in Table 11. To illustrate individual cell performance, the efficiencies of the best and worst cells are plotted in Figures 17 and 18.

Large standard deviations (above 2 percent) begin to appear within this set of 16 cells in their  $\rm V_{oc}$  below -50°C and below 0.128 SC. Similarly, large (above 2 percent) standard deviations appear in  $\rm V_{mp}$  at and below -50°C and, at and below 0.128 SC. Imp also shows significant (above 10 percent) standard deviations at and below -75°C and at and below 0.128 SC.

#### C. BSR 10 ohm-cm Silicon Cells

 $I_{\rm sc}$ ,  $V_{\rm oc}$ ,  $I_{\rm mp}$ ,  $V_{\rm mp}$ , and MP are plotted as functions of temperature and intensity in Figures 19 through 28. Average values with standard deviations are shown in Tables 12 through 16. Cell efficiencies are listed in Table 17 and plotted as functions of temperature and intensity in Figures 29 and 30. Similarly, the efficiencies of the best and worst cells are shown in Figures 31 and 32.

 $V_{\rm oe}$  shows standard deviations as large as 2 percent only at 0.040 SC below -75°C.  $V_{\rm mp}$  displays similar large (above 2 percent) standard deviations at and below -50°C and 0.086 SC.

#### D. BSR 2 ohm-cm Silicon Cells

I<sub>se</sub>, V<sub>oe</sub>, I<sub>mp</sub>, V<sub>mp</sub>, and MP are plotted as functions of temperature and intensity in Figures 33 through 42. Average values with standard deviations are summarized in Tables 18 through 22. Cell efficiencies are plotted as functions of temperature and intensity in Figures 43 and 44 and listed in Table 23. In addition, the best and worst cells efficiencies are plotted in Figures 45 and 46.

Large standard deviations begin to appear in  $V_{\rm mp}$  at -75°C and 0.063 SC and below. However, all of the standard deviations in the  $V_{\rm oc}$  observed for these 16 BSR 2 ohm-em cells were well below 1 percent.

#### IV. DISCUSSION OF RESULTS

#### A. General Features

A number of observations are made concerning the general characteristics of the data. The small standard deviations at and above 0.1 SC and -50°C in the data indicate that the measurements were apparently carried out with sufficient precision to enable discrimination of deviations of a few percent in the output from cell to cell at any given combination of temperature and light intensity. The small standard deviations in current which decrease with decreasing solar intensity are attributable to the beam nonuniformity of ±2 percent. There is some question as to whether a test lot of 16 cells is sufficient to provide reliable quality control statistics for these manufacturer lots at low temperatures and low intensities (LTLI).

Maximum power output was determined to be greatest at 1 SC/+25°C in the BSF/BSR 10 ohm-em cells and greatest at LTLI in the BSR 2 ohm-em cells. Large variations in V<sub>mp</sub> were observed in the BSF/BSR cells under LTLI as a reduction in the curvature of the I-V curve around the maximum power point. This reduction in curvature of the I-V plot is manifested in two forms — one as a softening of the I-V knee only and the other as a gradual decrease in current initiated in the low voltage portion of the curve. This reduction in curvature of the I-V plot results in lowering of the MP of the cell and thereby reduces solar cell efficiency. The magnitude of this occurrence in the three sets of cells

tested is seen in the fill factor distributions presented in Table 5. Efficiencies of the best and worst cells selected on the basis of maximum power output at 0.086 SC and -100°C show the extreme values in cell output within each test set. The current-voltage parameters listed for the best cells within each group in Table 4 demonstrate the capabilities of the individual cell type with the BSF/BSR cell have the highest efficiency at almost all test conditions. Mean efficiencies at 1 SC/+25°C were determined to be 14.1 percent for the BSF/BSR 10 ohm-cm cells, 12.1 percent for the BSR 10 ohm-cm cells, and 13.3 percent for the BSR 2 ohm-cm cells.

One of the objectives in this study was to find an observable solar cell feature present at room temperature which would correlate well with cell performance under low temperature and low intensity conditions. While there exists a visual correspondence between the ranking of the cells light I-V curves and their dark I-V curves, no single parameter in the light I-V curves could be determined at room temperature to correlate to the LTLI cell performance. Preliminary conclusions based on the dark current data provided in Table 3 show a correlation as follows: When the junction defects in the cell give a shunt resistance (R<sub>JD</sub>) below 500 ohms, the MP available at 0.086 SC and -100°C falls off sharply; above that value of R<sub>JD</sub> the presence of edge channel resistances (R<sub>CH</sub>) below 1K ohms appears to affect the available power output. Both R<sub>JD</sub> and R<sub>CH</sub> are available from the room temperature dark I-V curves as illustrated in Table 3.

## B. Comparison of Configurations — BSF/BSR 10 ohm-cm to BSR 10 ohm-cm

The BSF/BSR cells show a greater  $V_{\rm oc}$  than the BSR 10 ohm-cm cells at the higher temperatures and intensities — the difference in the average values being 79 mV at 1 SC/+50°C. However, this difference decreased with decreasing temperatures and intensities with a crossover occurring in the mean values at 0.063 SC/-125°C. The BSF/BSR cells show a decreasing change in  $V_{\rm oc}$  with temperature at the lower temperatures. Data on the best cells of each group (selected at 0.086 SC/-100°C) indicate a difference in  $V_{\rm oc}$  at 1 SC/+50°C of 57 mV with equivalent values at low temperatures and low intensities. No evidence of a Schottky barrier was present in any of the cells tested as would be manifested by a decrease in  $V_{\rm oc}$  with increasing solar intensity or by an increase in current near  $V_{\rm oc}$ . The application of the BSF to the BSR cell was apparently not successful in increasing the fill factor or  $V_{\rm oc}$  at LTLI as had been expected.

Short circuit current is greater in the BSF/BSR cells than in the BSR 10 ohm-cm cells at the higher temperatures and intensities — the difference in average values being 8 mA greater for the BSF/BSR cells at 1 SC/+50°C. This difference decreases with low temperatures and low intensities. The best cells of each set show similar values at LTLL.

Maximum power output at higher temperatures and intensities is greater in the BSF/BSR cells — 69.1 mW at 1 SC/+50°C compared to 55.5 mW for the BSR 10 ohm-cm cells with the difference decreasing with decreasing temperatures and intensities. Maximum power voltage and current show trends similar to  $V_{\rm oc}$  and  $I_{\rm sc}$  with the BSF/BSR cells having higher values at higher temperatures and intensities. The low shunt resistances evident at LTLI in the BSF/BSR cells reduce  $V_{\rm mp}$  and bring about lower efficiencies in three cells.

# C. Comparison of Base Resistivity — BSR 10 ohm-cm to BSR 2 ohm-cm

The  $V_{oc}$  in the 2 ohm-cm cells was approximately 50 mV higher than that in the 10 ohm-cm cells throughout the test profile. No decrease in  $V_{oc}$  with temperature at LTLI was evident in the 2 ohm-cm cells. The large standard deviations (above 2 percent) in the 10 ohm-cm cells at 0.04 SC and at -150°C and below indicate decreases in  $V_{oc}$  in some of the 10 ohm-cm cells.

Average values of short circuit current were 3 mA higher in the 10 ohm-cm cells at 1 SC/+25°C. This difference decreased with decreasing temperatures and intensities with a crossover in the data occurring at 0.063 SC/-100°C. The best cells of each group show a similar trend.

The MP produced by the 2 ohm-cm cells is greater than the 10 ohm-cm cells throughout the test profile. The higher values of  $V_{\ mp}$  available in the 2 ohm-cm cells are responsible for the greater MP values and the subsequent higher efficiencies. The trend in I  $_{\ mp}$  in these cells is similar to that of the short circuit current. The 2 ohm-cm cells showed the most consistent cell-to-cell electrical characteristics at both high temperatures and intensities and at low temperatures and intensities.

#### D. Calculation of Model Parameters from Dark I-V Data

To correlate individual cell performance with one or more of its physical features such as edge channel resistance or shunting junction resistance, the dark I-V curves were analyzed by means of an equivalent circuit for the cell. The principal effects of shunting around the solar cell junction by edge channels and junction defects were represented with the simplified equivalent circuit in Figure 47. By treating the diodes as switches the cell in the dark should show:

- 1) At low forward bias (< 0.2 V), an equivalent resistance of  $\rm R_{S} + \rm R_{JD}$
- 2) At high forward bias (a temperature dependent value  $\geq$  0.8 V) an equivalent resistance of  $R_{\rm S}$ .
- 3) At intermediate bias (when the edge channel diode is switched on but the cell junction diode is still off) an equivalent resistance of

$$R_{S} + \frac{1}{R_{GH}^{-1} + R_{JD}^{-1}}$$

Values of these three resistances,  $R_{\rm S}$ ,  $R_{\rm JD}$  and  $R_{\rm CH}$ , have been caleulated from the dark I-V curves and are listed in Table 3 for the best and worst cells selected from these three test sets.

The general features of the simplified model parameters in Table 3 show that:

- 1) The effective series resistance,  $R_{\rm S}$ , is consistently low as it should be for high performance cells, with no change from best to worst performance in these three sets of 16. The temperature dependence of  $R_{\rm S}$  may be interpreted as due to the temperature dependence of the carrier concentration in the n and p regions of the silicon wafer.
- 2) The shunting defects in the cell junction, represented by  $\rm R_{JD}$ , seem to be responsible for the reduction in performance from best to worst at room temperature in all three sets with the singular exception of cell 15 in the BSR 2 ohm cm set. Similarly, at -150°C, the worst BSF/BSR cells had their junctions shunted by an effective low resistance; the temperature dependence of  $\rm R_{JD}$  in these two cells indicates the type of defect existing within their junction becomes a more effective shunt at low temperature. However, the worst BSR cells at low temperature showed remarkably high values of  $\rm R_{JD}$  indicating that the reduction in MP at low temperature is due to some other differences between the cells; the defects in the BSR junctions are of such a type that, in the dark, they require temperature activation to shunt significant currents across the junction.
- 3) The edge channel resistances, assuming all the edge channels have a diode switching voltage \$ 0.2 V, have values near 500 ohms at 25°C and near 1K ohms at -150°C. Therefore the edge channel resistance is the principal shunt resistance during maximum power operation in all of the cells tested, except the two poorest of the BSF/BSR set where junction defects are so bad.

#### V. SUMMARY

The BSF/BSR 10 ohm-em cells provided the best performance at 1 SC/+25°C (14.1 percent efficiency) but failed to provide the best performance at LTLI. However, these cells are capable of high performance at LTLI based on the behavior of the best cell in the set. The BSR 2 ohm em cells had the highest LTLI performance (22.2 percent efficiency at 0.04 SC/~170°C for the set) and the most consistent cell-to-cell characteristics. The performance observed for the three sets of cells is summarized by the graph of relative maximum power output, P/Po (Po is the power produced at 55°C at 1 AU) versus heliocentric distance in Figure 48. Figure 49 represents the array mission temperatures used in generating the data. The two sets of BSR configured cells produce approximately the same P/Po outputs at large AU's. They give, for 0.150 for the 10 ohm cm base resistivity cell and 0.148 example, P/Po for the 2 ohm-em base resistivity cell at 3.4 AU conditions. However, the mean of the 16 BSF/BSR cells produced P/Po of only 0.118 at 3.4 AU conditions.

The observed spread in several of the parameters in these data was well below 1 percent. Therefore, the simulation techniques used to obtain the solar cell performance is capable of making active parameter measurements to better than 2 percent.

Finally, cell characteristics revealed by the dark I-V at room temperature show potential as useful indicators of the cell performance at low temperatures and low intensities.

TABLE 1. TEST CELL DESCRIPTIONS

Test Group 1
N/P BSF/BSR Silicon
$2 \times 2 \times 0.025$ cm
10
Shallow (0.2 to 0.25 µm)
Ti-Pd-Ag
Fine Line (3/15)
FS 0.35 Cut-on (0.3 µm Thick)
93-500
0.74
Production Run

TABLE 2. TEST PROFILE

Illumination Level (SC)	Temperature (°C)
1.00	0, 25, 50
0.64	-25, 0, 25, 50
0.39	-50, -25, 0, 25, 50
0.25	-75, -50, -25, 0, 25
0.174	=100, -75, -50, -25. 0
0.128	-125, -100, -75, -50, -25
0.086	-150, -125, -100, <b>-7</b> 5, <b>-</b> 50
0.063	-150, -125, -100, -75, -50
0.040	-175, -150, -125, -100, -75
Dark I-V	25, 0, -25, -50, -75, -100, -125, -150, -175

Note: -175°C was not achievable in two of the three test groups.

SC = Solar Constant.

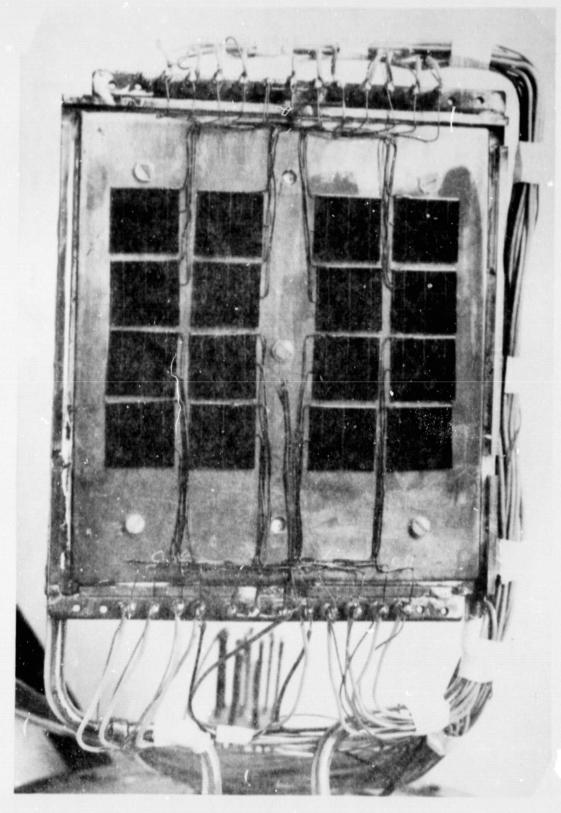
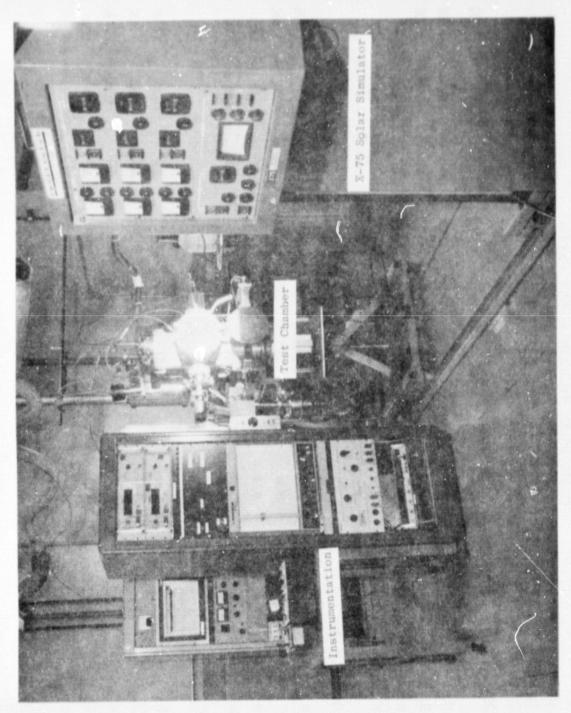


Figure 1. Solar cell test plate.

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Solar cell characterization equipment and instrumentation. Figure 2.

TABLE 3. EQUIVALENT CIRCUIT RESISTANCES OF SELECTED INDIVIDUAL SILICON SOLAR CELLS

(smho	RCH	1.2K 1.1K	1		1 017	1.0K	009	550		111	1.1K	1.0K	800
Resistances (ohms) at -150°C	$R_{\mathrm{JD}}$	$100^{\dagger}\mathrm{K}$ $30\mathrm{K}$	90	30	>>100K	7K	>>100K	$100^{7}\mathrm{K}$		1001	100K	100K	$100^{\ddagger}\mathrm{K}$
Re	a S	65	62	09	64	65	64	64		i.	65	65	65
(ohms)	$^{ m R}_{ m CH}$	560	1	}	500	550	I	~700		009	009	550	550
Resistances (ohms)	$ m ^{R}_{JD}$	100K 100K	300	001	5K	5K	200	1.1K		20K	20K	20K	4K
	R S	39 39	38	,	35	35	35	35		37	37	37	38
Max Power (mW)		9.6 9.4	6.1		8.9	0.6	6.9	6.8		9.5	9.4	8.7	8.5
Cells	BSF/BSR 10 ohm cm	$egin{array}{c} \mathtt{B}_1 \\ \mathtt{B}_2 \\ \mathtt{C}_2 \end{array}$	$W_1 \\ W_2$	BSF/BSR 10 ohm cm	$_{ m B}_{ m 1}$	B <sub>2</sub>	, T	2	BSR 2 ohm cm	$^{\mathrm{B}_1}$	$^{\mathrm{B}_2}$	1, 1	W <sub>2</sub>

B = Best, W = Worst, based on max power output at 0.086 SC/-100°C.

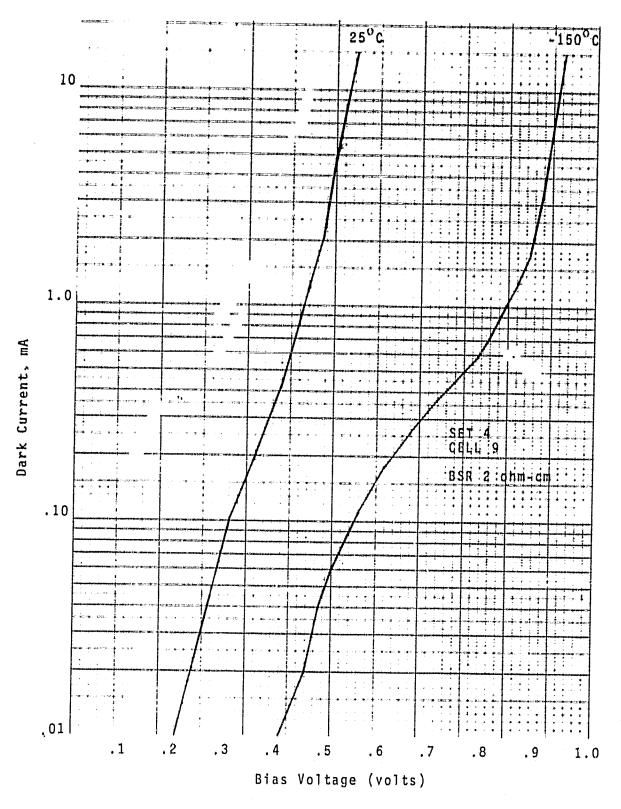


Figure 3. Dark current versus bias voltage for a good cell.

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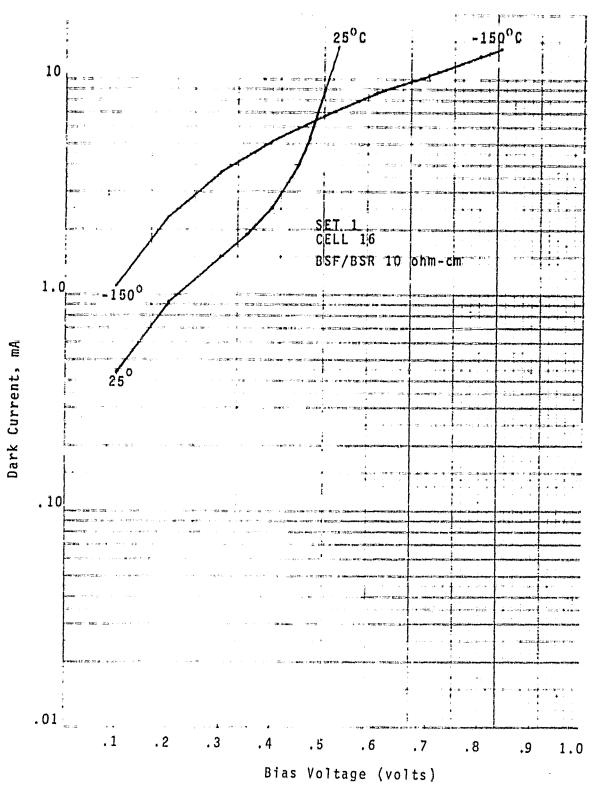


Figure 4. Dark current versus bias voltage for a bad cell.

TABLE 4. CURRENT-VOLTAGE PARAMETERS OF THE BEST CELLS

Type Silicon Cell

Parameter	BSF/BSR 10 ohm-em	BSR 10 ohm-em	BSR 2 ohm-em
$I_{se}$			
1 SC/25°C 0.086 SC/-100°C 0.040 SC/-150°C	164.0 13.9 6.0	161 14.0 6.8	155 $13.4$ $7.2$
v <sub>oe</sub>			
1 SC/25°C 0.086 SC/~100°C 0.040 SC/~150°C	605 797 903	548 793 893	598 822 908
$I_{mp}$			
1 SC/25°C 0.086 SC/-100°C 0.040 SC/-150°C	157 $12.8$ $6.4$	152 12.6 6.3	148 12.7 6.8
$v_{mp}$			
1 SC/25°C 0.086 SC/-100°C 0.040 SC/-150°C	485 750 828	445 718 713	490 748 762
MP			
1 SC/25°C 0.086 SC/-100°C 0.040 SC/-150°C	76.1 $9.6$ $5.3$	67.6 9.1 4.5	72.7 9.5 5.2
Eff			
1 SC/25°C 0.086 SC/-100°C 0.040 SC/-150°C	14.1 20.6 24.4	12.5 19.5 20.8	13.4 20.4 24.0

Note: Best cells selected for best efficiency at Max Power at 0.086 SC/-100°C.

TABLE 5. FILL FACTORS FOR ALL CELLS

0.84 to 0.85 (2)

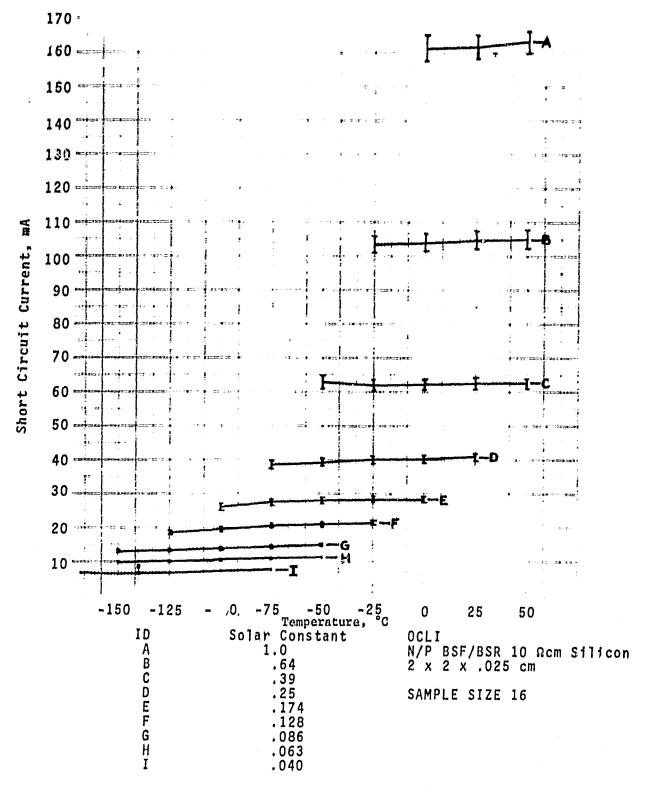


Figure 5. Average I sc as a function of temperature.

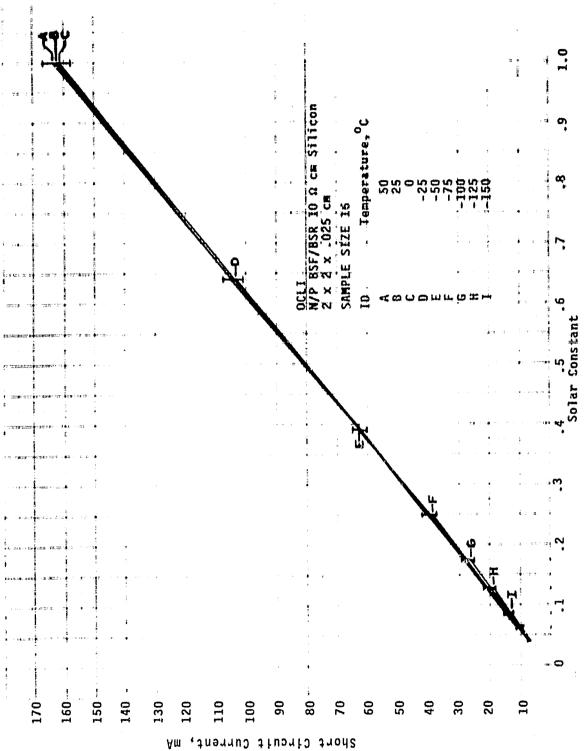


Figure 6. Average  $I_{SC}$  as a function of intensity.

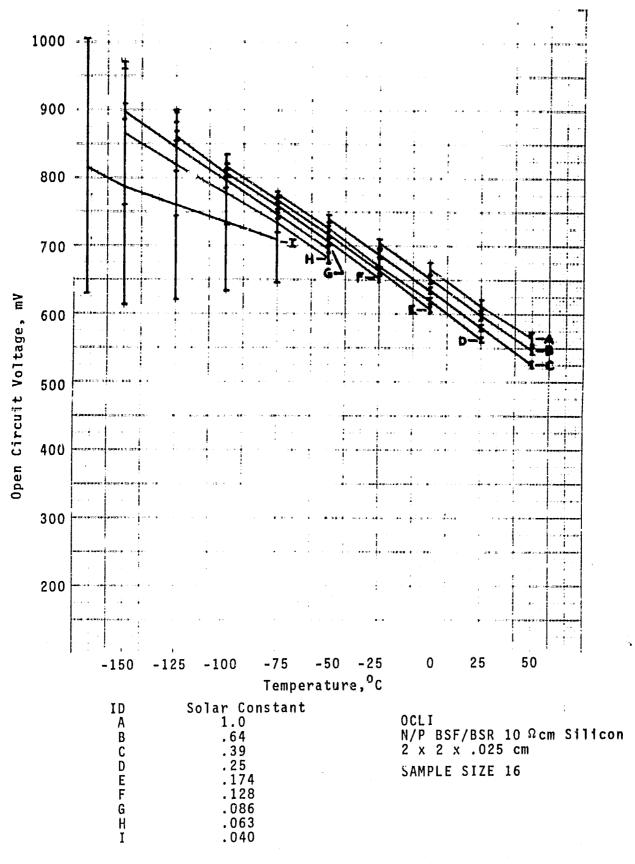
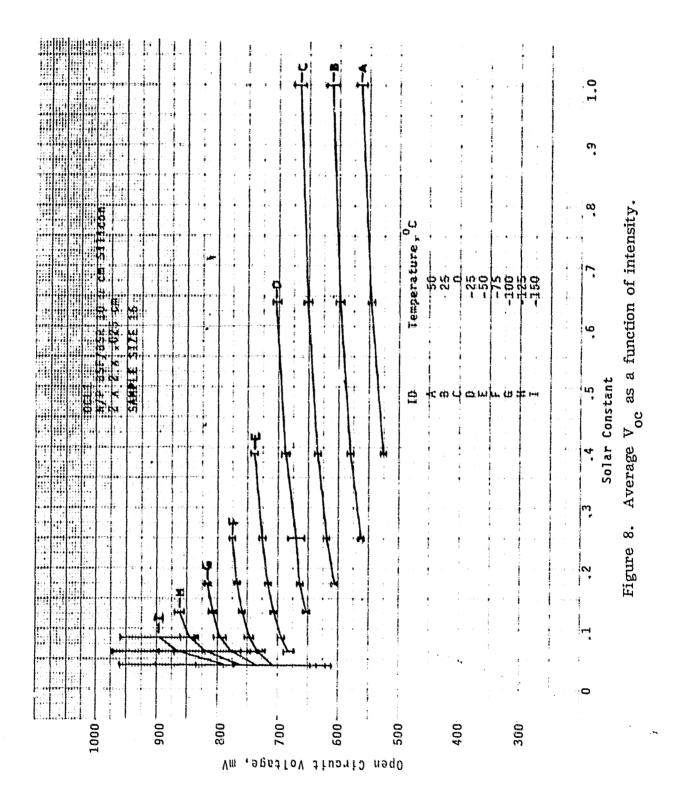


Figure 7. Average  $V_{\text{oc}}$  as a function of temperature.

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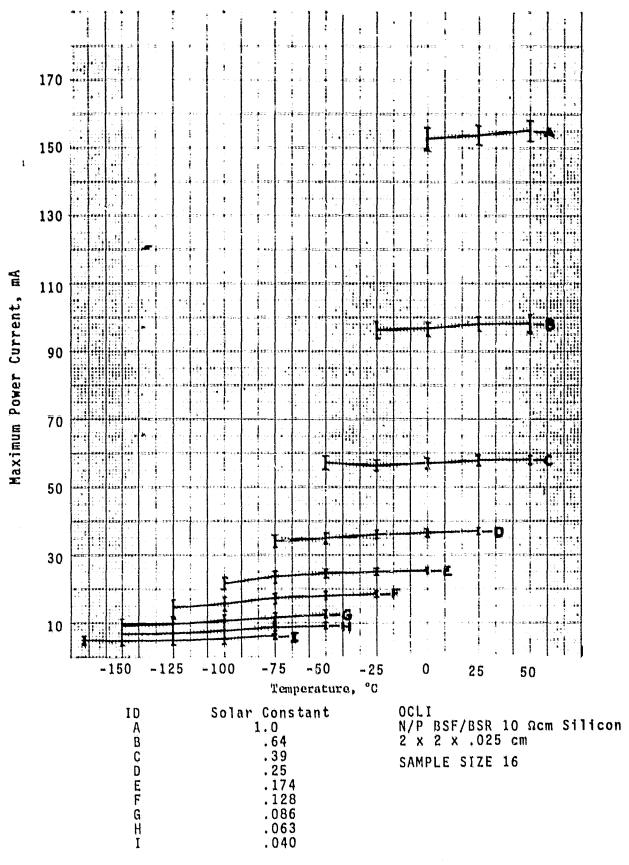
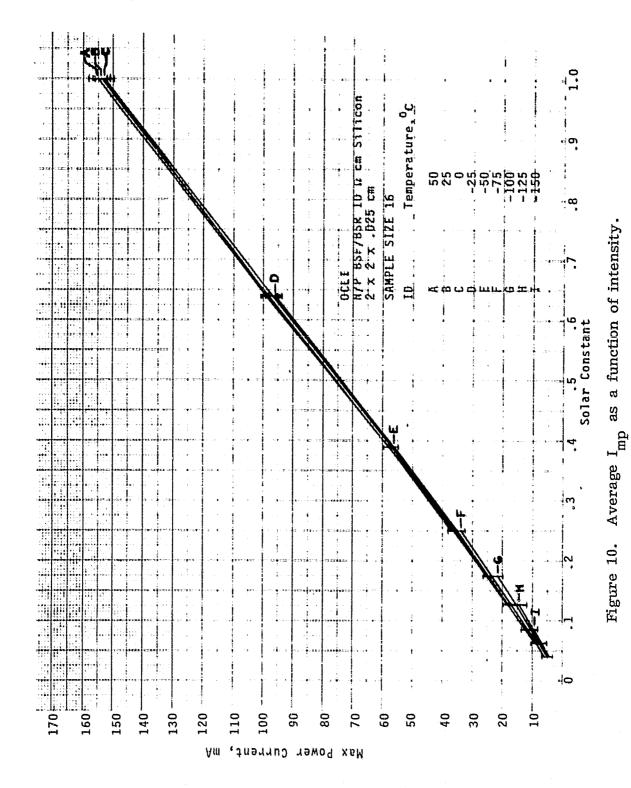


Figure 9. Average  $I_{\mathrm{mp}}$  as a function of temperature.

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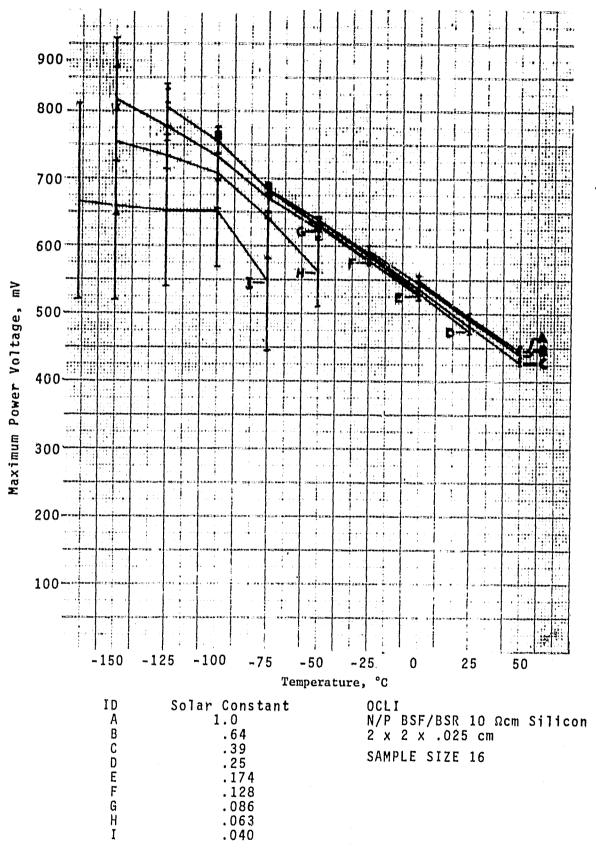
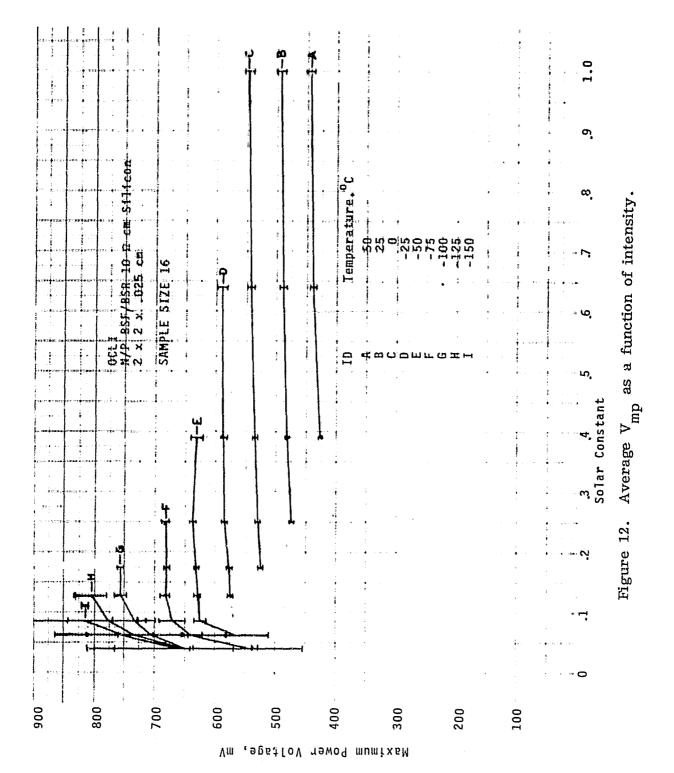


Figure 11. Average  $V_{mp}$  as a function of temperature.



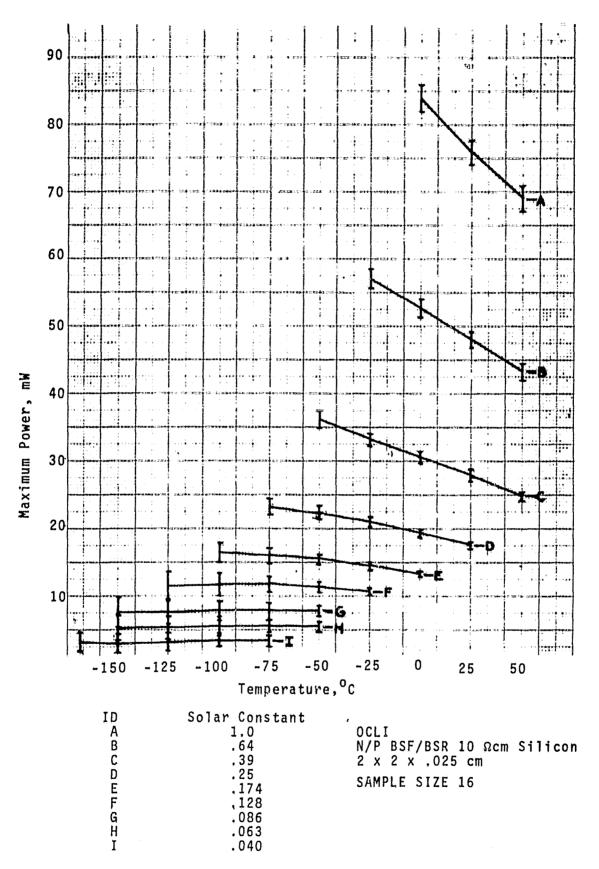
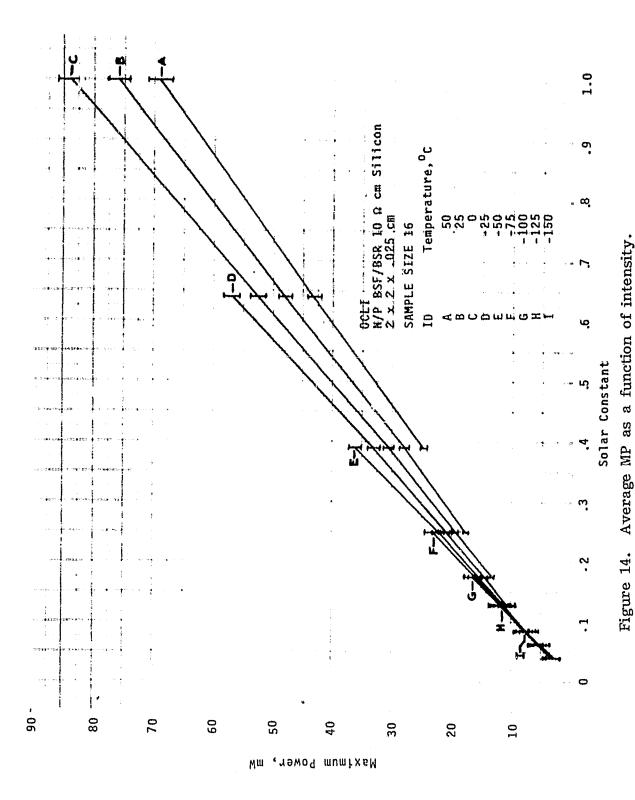


Figure 13. Average MP as a function of temperature.

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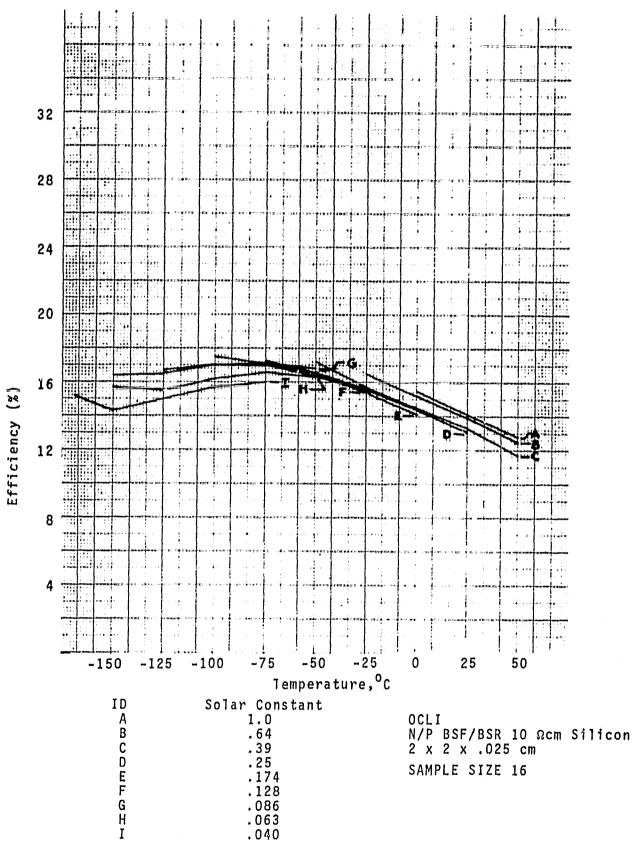
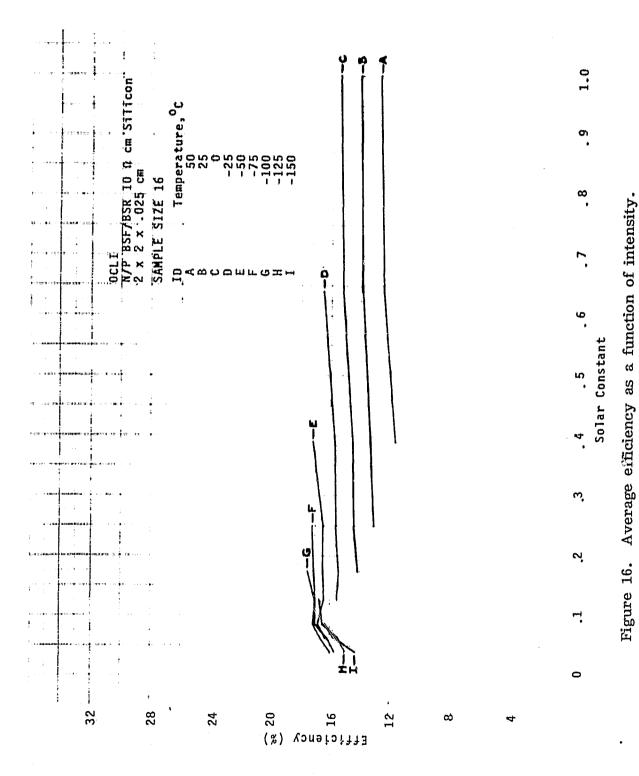


Figure 15. Average efficiency as a function of temperature.



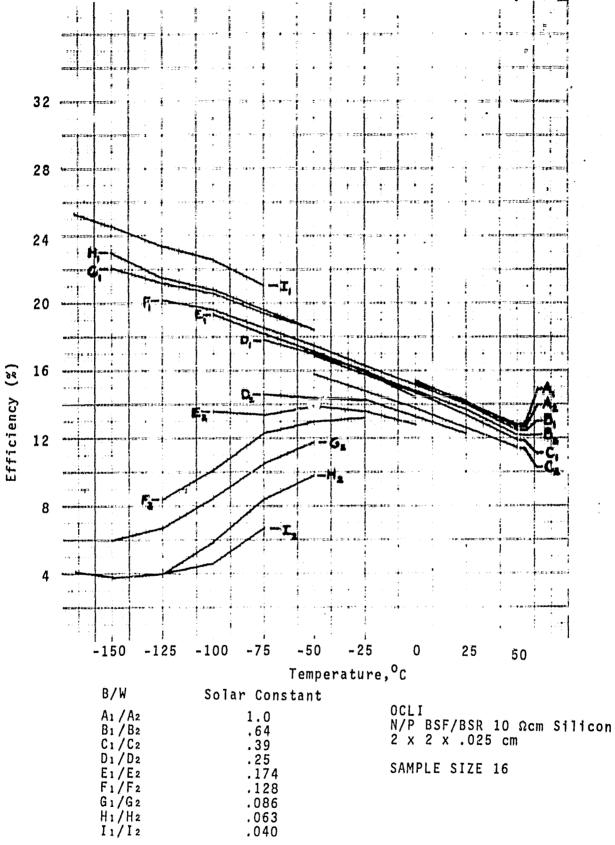
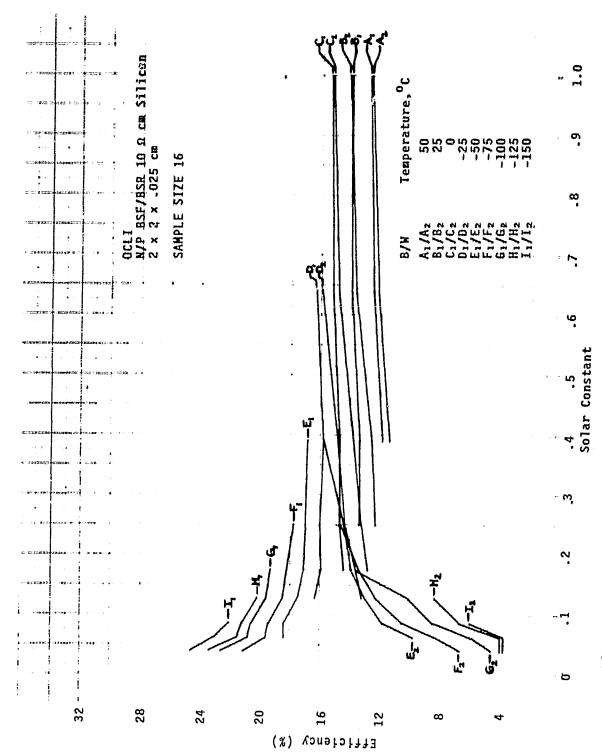


Figure 17. Efficiency of the best/worst cells as a function of temperature.



Efficiency of the best/worst cells as a function of intensity. Figure 18.

TABLE 6. AVERAGE  $I_{SC}$  (mA)

		0.04					7.4	7.2	6.9	6.8	6.9
		0.063				11.2	10.9	10.4	10.0	9.9	
ka ba		0.086				15.0	14.6	13.9	13.4	13.1	
OCLI N/P BSF/BSR 10 n cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Multilayer (Blue) AR Coating FS Cover 0.35 n Cut-on (.300 um thick) SAMPLE SIZE 16	tants	0.128			21.5	21.1	20.7	19.6	18.7		
BSF/BSR 10 ß cm Silicon 2 x .025 cm 2d-Ag Contacts 3/15 Line tilayer (Blue) AR Coatin Cover 0.35 g Cut-on (.300 cm thick)	Solar Constants	0.174		28.5	28.5 (.8)	28.2 (.8)	27.6 (.8)	26.1 (1.0)			
OCLI N/P B3 2 x 2 2 x 2 Ti-Pd- Hulti FS Cov		0.25	41.0	40.5	40.1	39.5	38.8				
		0.39 62.5 (1.5)	62.6 (1.7)	62.2 (1.6)	62.0 (1.6)	63.0 (2.0)					
		0.64 105.0 (2.8)	104.8 (2.5)	104.0 (2.7)	103.5 (2.5)						
	ıre	1.0 163.3 (3.4)	161.9	161.5							
	Temperature	20 <sub>0</sub> C	25 <sub>0</sub> c	ე <sub>ი</sub> 0	-25°C	-50°C	-75°C	-100°د	-125 <sup>0</sup> c	-150°C	-168 <sup>0</sup> C

NOTE: Standard Deviations Are Given In Parentheses

TABLE 7. AVERAGE Voc (mV)

•		96.0					709.9	(100.1)	761.6	787.5 (174.2)	(188.1)
		0.063				683.1	734.5	777.3	820.8	866.9 (106.1)	
		0.086				695.1 (5.6)	747.4 (6.8)	(10.5)	846.9 [36.6]	898.9	
cm Silicon 3/15 Lines AR Coating ut-on thick)		0.128			653.1	707.4 (4.6)	759.2	808.9	862.6 (7.6)		
OCLI N/P BSF/BSR 10 D cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Line Multilayer (blue) AR Coatin FS Cover 0.35 p Cut-on (.300 pm thick)	Solar Constants	0.174		607.9 (4.2)	664.1	7.17.7 (4.2)	768.0 (4.1)	817.5 (4.5)			
OCLI N/P BSF/BS Z X Z X O Ti-Pd-Ag C Multilayer FS Cover (	Solar	0.25	563.3 (4.2)	620 (4.4)	670.9	726.4 (4.8)	776.7 (4.4)				
		0.39 526.6 (4.3)	580.1	635.6	688.9	739.9					
		0.64 547.3 (5.5)	598.7 (6.3)	652.3 (6.5)	704.1 (6.8)						
	ō	1.0 564.8 (8.3)	613.7 (8.7)	(6.6,7							
	Temperature	ე <sub>ი</sub> 09	25°C	ე <sub>ი</sub> 0	-25°C	ე <sub>ი</sub> 05-	-75°C	-100 <sub>0</sub> c	-125°C	-150°C	-168 <sup>0</sup> c

Standard Deviations Are Given In Parentheses NOTE:

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		0.04					6.1	5.1 (1.3)	4.8 (1.4)	4.6 (1.3)	4.9
		0.063				9.2	8.7 (1.0)	7.8 (1.6)	7.0 (1.8)	6.9	
		0.086				$\frac{12.5}{(1.1)}$	11.8 (1.3)	10.8 (1.7)	9.7	9.2 (2.0)	
cm Silicon 3/15 Lines AR Coating 1t-or thick)	ıts	0.128			18.7	18.1 (1.2)	17.3	15.5 (2.1)	14.3 (2.5)		
N/P BSF/BSR 10 Ω cm Silicon 2 x 2 x .025 cm 2 x 2 x .025 cm 2 x 2 x .025 cm 2 x 1.5 Line Multilayer (blue) AR Coatin FS Cover 0.35 μ Cut-or (.300 μm thick)	Solar Constants	0.174		25.4 (.9)	25.1 (1.0)	24.6 (1.2)	23.6 (1.7)	21.7 (1.8)			
OCLI N/P BSF 2 x 2 x Ti-Pd-A Ti-Pd-A Multila FS Cove	So	0.25	37.2 (1.0)	36.6	36.0 (1.2)	35.11 (1.5)	34.1 (1.7)				
	*	0.39 58.0 (1.2)	58.0	57.1 (1.5)	56.4 (1.5)	57.1 (2.0)					
		0.64 98.3 (2.6)	98.1 (2.1)	96.9 (2.4)	96.2 (2.4)						
	ā	1.0 155.2 (3.1)	153.9 (2.E)	152.9							
	Temperature	3 <sub>0</sub> 05	- 25°C	ე <sub>ი</sub> 0	-25°C	ე <sub>0</sub> 09	-75°C	-100 <sub>0</sub> c	-125°C	-150°C	-168 <sup>0</sup> C

NOTE: Standard Deviations Are Given In Parentheses

(mV)
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		9.08						848 80 80 80 80 80 80 80 80 80 80 80 80 80	652.9 (83.6)	652.2 (113.5)	660.5 (140.8)	665.0 (146.6)
		9.063					San San San San San San San San San San	6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6	(52.8)	734.7	755.5	
א ט		0.686					000 000 000	671.5	733.8 (35.0)	778.5	818.3	
co Silicon 3/15 Lines 3/16 Coating Cut-on thick)	cants	0.128				576-3 (4.2)	629.1		(10.2)	806.6 (26.0)		
OCLI N/P BSF/BSR 10 % cm Silico 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lin Multilayer (blue) AR Coati FS Cover 0.35 % Cut-on (.390 cm thick) SAMPLE SIZE 16	Solar Constants	0.174			525.2 (4.4)	577.2	631.4	6621.7.2	756.6			eses.
S FRAILPARE		0.25		474.7	530.7 (3.9)	585.5	65.47.2	683.5				In Parentheses
		0.39	(3.6)	482.5 (3.0)	536.3	588	633.8					. Are Given
		0.64	440-4	490.3 (6.2)	544.3	. 392 (8.35)						Deviations
	gre	0	(7.5)	7.20	548.6							Standard Devi
	Temperature		ပ စု ရ	25°C	್ಕಾಂ	ე <sub>ი</sub> ⊆2-	⊃ <sub>0</sub> 05-	Je€′-	3 <sub>0</sub> 001-	-125°C	-150°C	-168°C NOTE:

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Standard Deviations Are Given In Parentheses.

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		0.04						4.0	3.4	3.2	(M) per 12	(3) (3)
		0.083					(S)	(1.0)	5.5 (1.4)	5.3	5.4	
		0.086					(e.)	7.79	7.9	7.7 (1.9)	7.6	
cm Silicon 3/15 Lines AR Coating ut-on thick)		0.128				10.8	11.4	11.8	11.8 (1.7)	(2.2)		
r r cts	Solar Constants	0.174			13.3	14.5	15.5	16.1	16.5			
0CLI M/P BSF/BSR 10 2 x 2 x .025 cd x 2 x .025 cd Ti-Pd-Ag Conta Hultilayer (b1) FS Cover (0.35 FS Cover (0.35) SAMPLE SIZE 16	Sola	0.25		17.7	19.4	21.1	22.4 (1.0)	23.3				
		0.39	24.8 (.6)	28.0	30.6	33.1	36.2 (1.2)					
		0.64	43.3 (1.3)	48.1	52.7 (1.3)	57.1						
		0.1	69.1 (1.9)	76.0	83.9 (2.0)							
	Temperature		ე <sub>ი</sub> 09	25°C	್ <mark>ರ</mark> ೦	-25°C	ე <sub>ი</sub> 09-	-75°C	-100°C	-125°C	J <sub>0</sub> 051-	-168 <sup>0</sup> C

NOTE: Standard Deviations Are Given In Parentheses

TABLE 11. AVERAGE EFFICIENCY (%)

		0.04						16.0	15.7	15.0	14.3	15.2
;		0.063					16.3	16.6	16.2	15.5	15.7	
ilicon 5 Lines Coating n		0.086					16.8	17.1	17.0	16.5	16.4	
3R 10 Ω cm 8 225 cm 10 to	Solar Constants	0.128				15.5	16.4	17.0	17.0	16.7		
OCLI N/P BSF/BSR 10 \( \alpha\) cm Silicon 2 \( \times\) Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating FS Cover 0.35 \( \times\) Cut-on (.300 \( \times\) \( \times\) CAMPIF SIZE 16	Solar C	0.174			14.1	15.4	16.5	17.1	17.5			
		0.25		13.1	14.4	15.6	16.5	17.2				
		0.39	11.7	13.3	14.5	15.7	17.2					
		0.64	12.5	13.9	15.2	16.5						
	ıre	1.0	12.8	14.1	15.5							
	Temperature		ე <sub>0</sub> 09	25°C	٥ <sub>0</sub> 0	-25°C	2 <sub>0</sub> 05-	-75°C	-100°C	-125°C	-150 <sub>0</sub> c	-168 <sup>0</sup> C

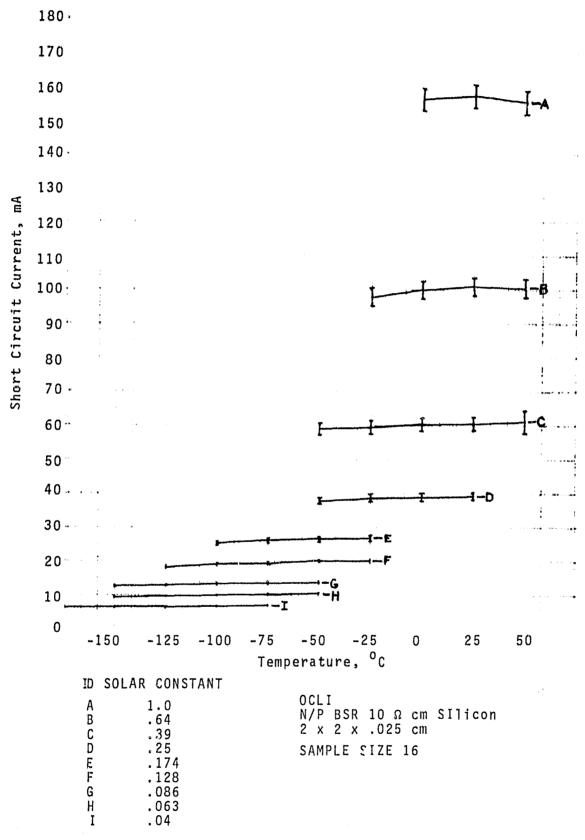


Figure 19. Average  $I_{sc}$  as a function of temperature.

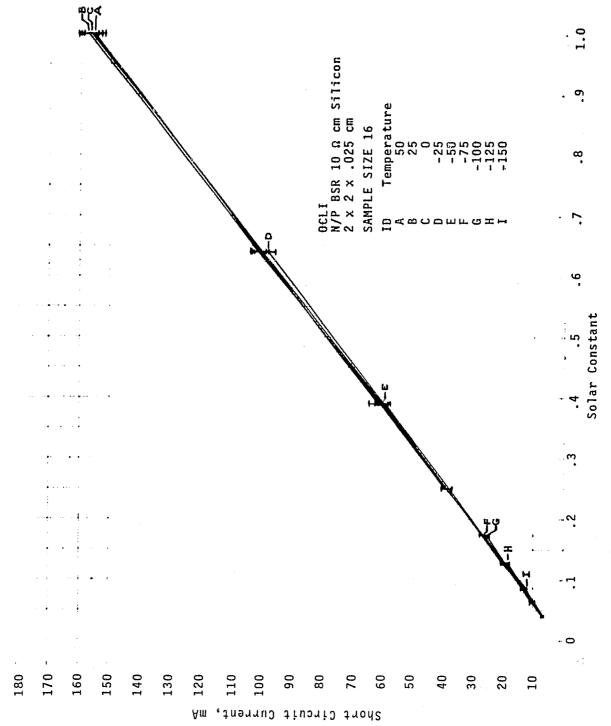


Figure 20. Average  $I_{sc}$  as a function of intensity.

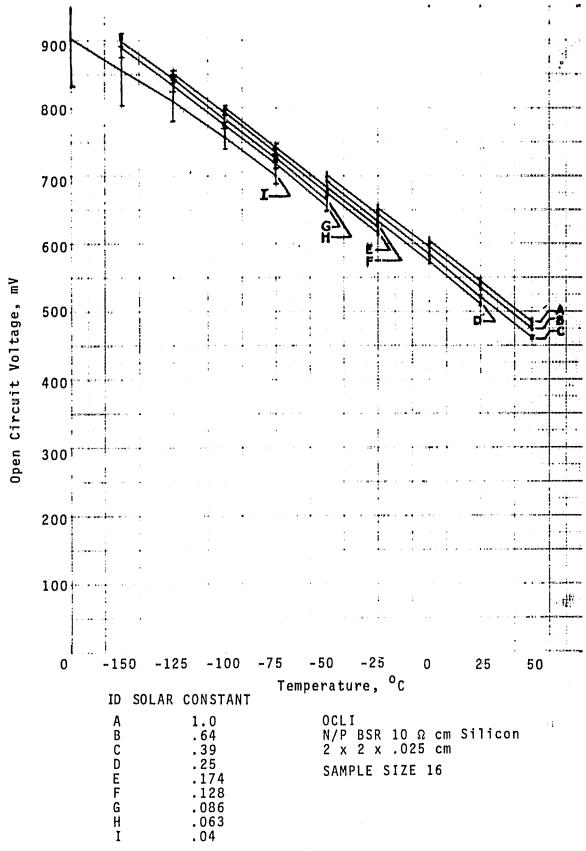
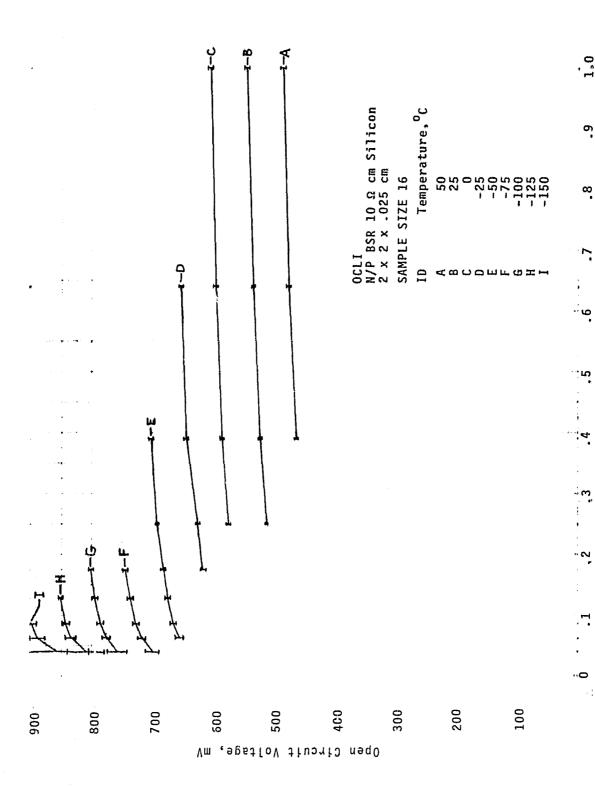


Figure 21. Average  $V_{oc}$  as a function of temperature.



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Figure 22. Average  $V_{oc}$  as a function of intensity.

Solar Constant

43

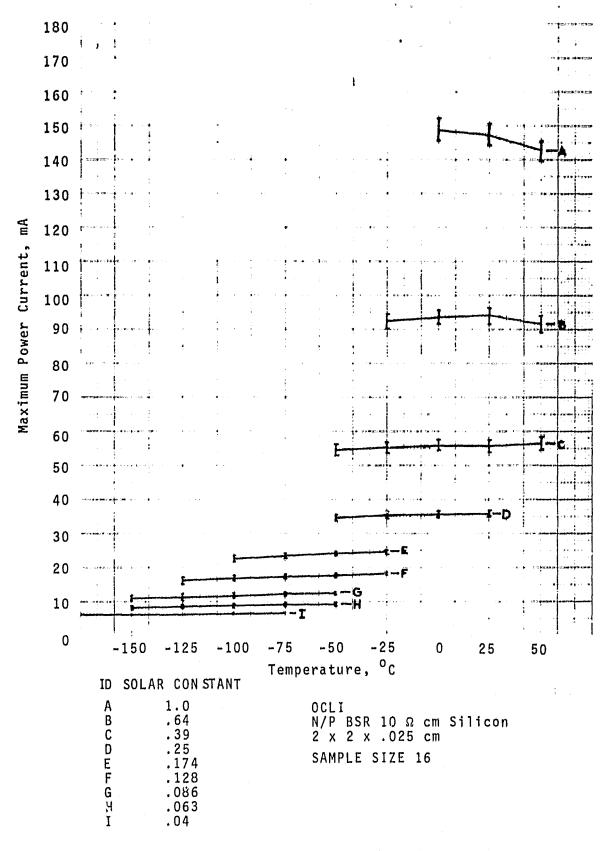
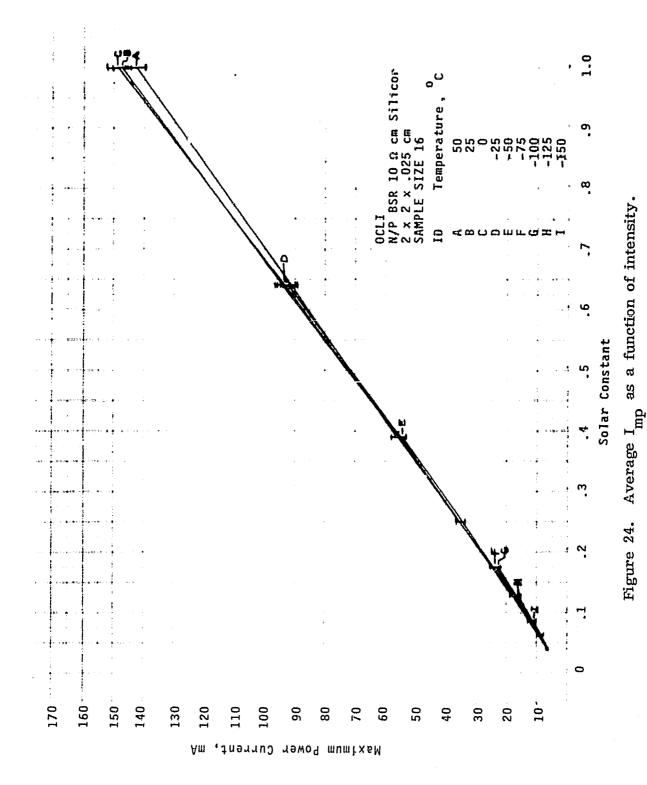


Figure 23. Average  $I_{mp}$  as a function of temperature.



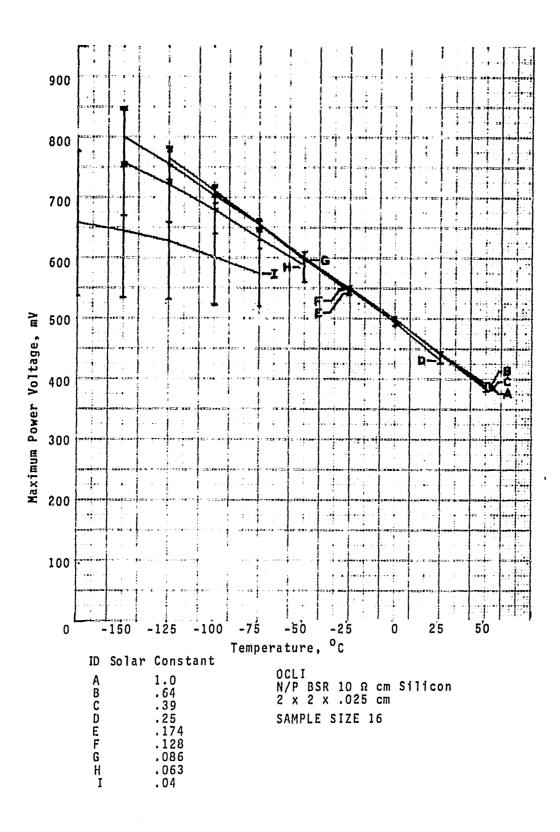


Figure 25. Average  $\mathbf{V}_{mp}$  as a function of temperature.

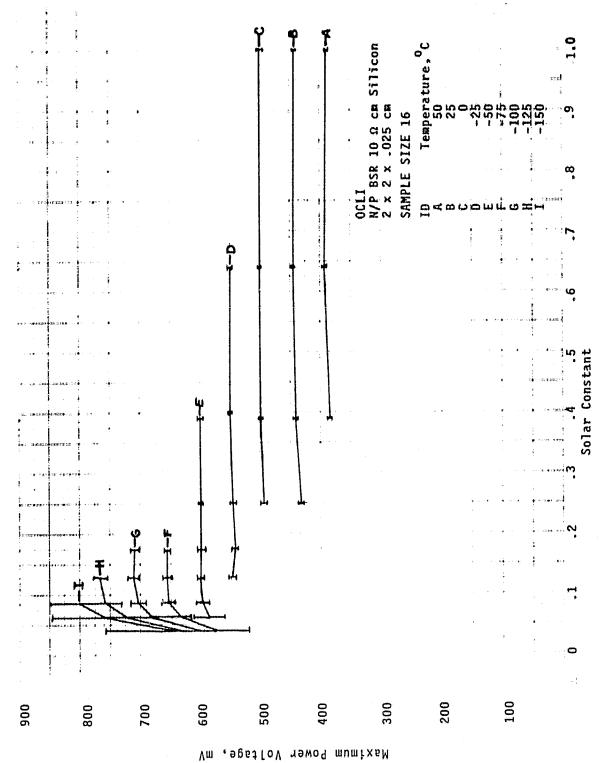


Figure 26. Average  $V_{mp}$  as a function of intensity.

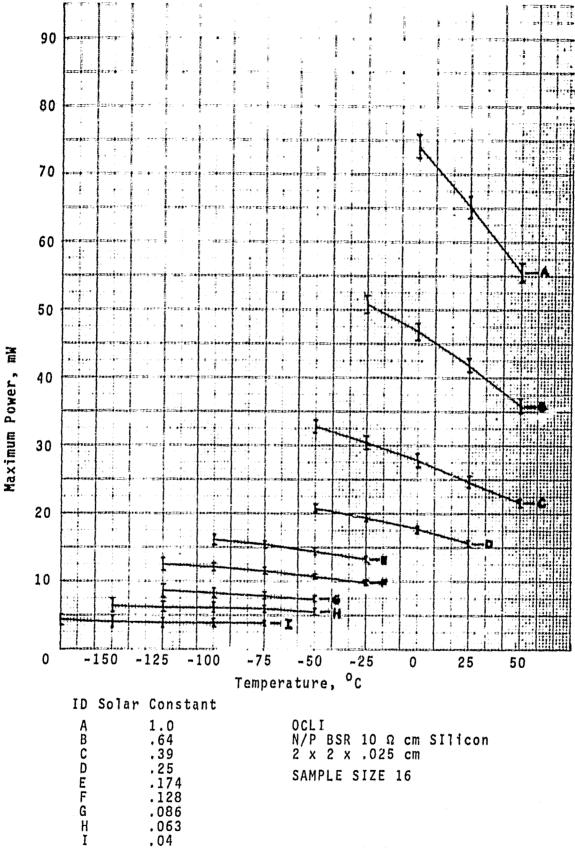


Figure 27. Average MP as a function of temperature.

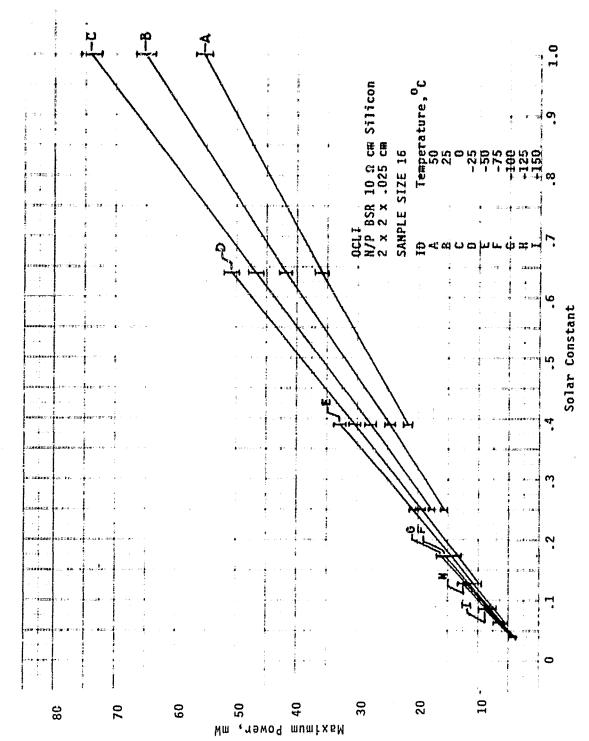


Figure 28. Average MP as a function of intensity.

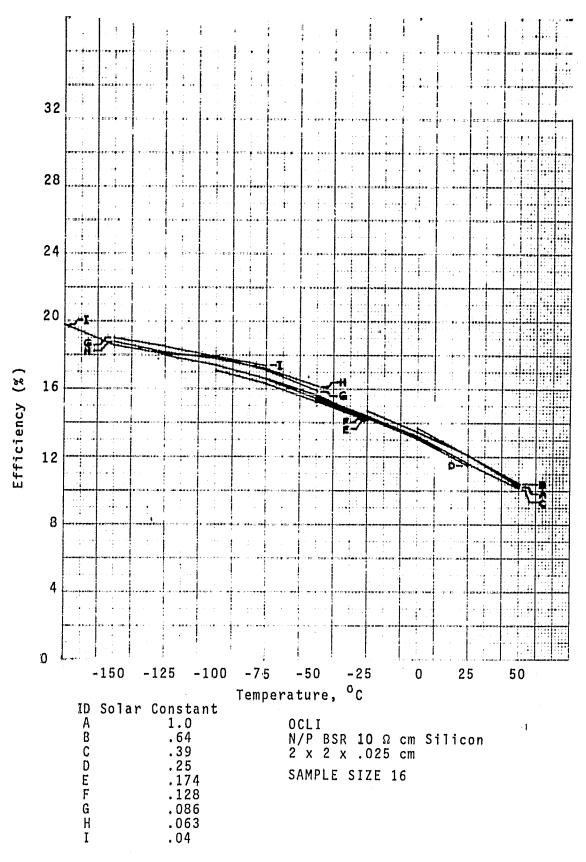


Figure 29. Average efficiency as a function of temperature. In PAGE IS POOR ORIGINAL PAGE IS POOR

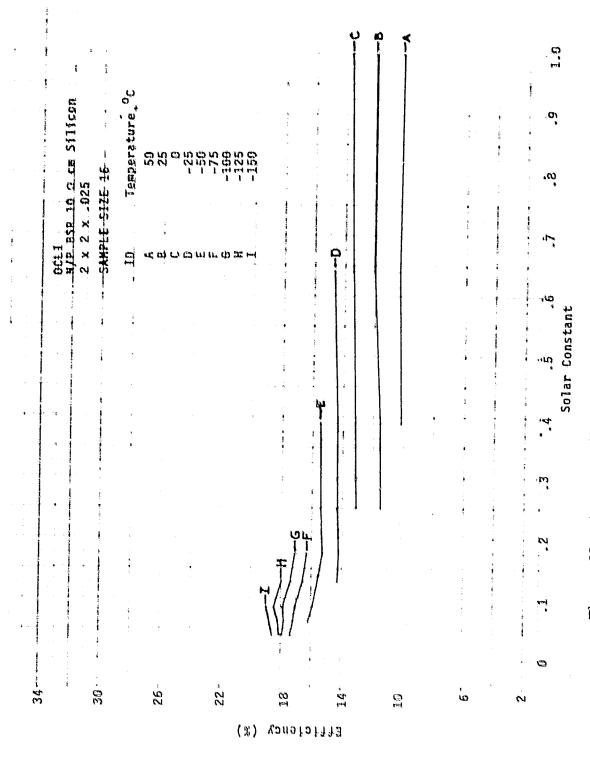


Figure 30. Average efficiency as a function of intensity.

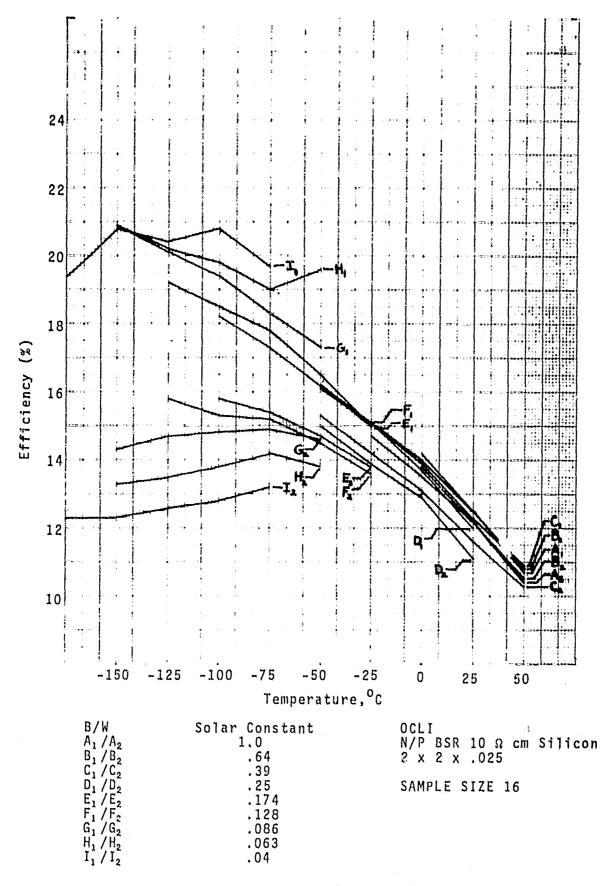


Figure 31. Efficiency of the best/worst cells as a function of temperature.

					30° wied	ı			•	1.0
Silicon siure, C			•	•						oj.
10 0 сm Silic .025 сm SiZE 16 .iemperature	25 25	-50 -75 -100 -125 -150					•		: (	xo,
0¢LI N/P BSR 2 × 2 × SÅMPLE S	me for one of	E1/E2 F1/F2 G1/G2 H1/H2		99					 	;
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				ciency	1113					

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Figure 32. Efficiency of the best/worst cells as a function of intensity.

TABLE 12. AVERAGE I<sub>SC</sub> (mA)

			0.04						7.0	6.90	6.7	6.7	6.6
:			0.063				10.6	(.4)	10.4	10 (0)	9.9	9.8	
		c c	0.080				13.9	(.3)	13.7	13.3	13.0	12.8	
on 5 Lines Coating n k)		0 128				20.1	20.1	(+-)	19.5	19.2 (.5)	18.4		
N/P BSR 10 Ω cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating FS Cover 0.35 μ Cut-on (.300 μm thick) SAMPLE SIZE 16		0.174				26.9	26.5		26.1 (.8)	25.4 (.6)			
OCLI N/P BSR 10 Ω C 2 x 2 x .025 c Ti-Pd-Ag Conta Multilayer (bl FS Cover 0.35 (.300	200	0.25		39.2 (1.0)	39.0 (1.1)	38.8	37.9						Parentheses
		0.39	61.1 (3.2)	60.5 (1.8)	60.3 (1.8)	59.5 (1.8)	59.0 (1.8)						re Given in
		0.64	100.5 (2.6)	101.	360 (2.5)	97.9 (2.6)							viations An
	ure	1	155.4 (3.5)	157.4 (3.4)	156.3 (3.3)								Standard Deviations Are
	Temperature		50 <sub>0</sub> د	25°C	ე <sub>0</sub> 0	-25°C	ე <sub>0</sub> 09-	-75°C	-100 <sub>0</sub> c	-125°C	-150°C	-175°C	NOTE:

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TABLE 13. AVERAGE V<sub>oc</sub> (mV)

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			0.04						700.8 (21.4)	75%.4 (15.8)	810 (31.7)	857.7 (53.7)	903.3 (70.9)
			0.063					655.8 (6.5)	717.9 (6.9)	775.8 (7.5)	834.6 (8.9)	889.1 (13.6)	
S 6.			0.086					666.3 (5.1)	727.1 (5.4)	784.9 (5.4)	843 (5.8)	899.8 (7.0)	
Silicon ss 3715 Lines AR Coating Cut-on	•	ıts	0.128				616.9 (3.8)	675.8 (4.2)	736.9 (4.2)	794.0 (4.5)	851.0 (4.0)		
OCLI N/P BSR 10 n cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lir Multilayer (blue) AR Coati FS Cover 0.35 p Cut-on (.300 um thick)	SAMPLE SIZE 16	Solar Constants	0.174				625.2 (3.3)	682.9 (3.7)	743.8 (4.1)	800.8 (3.6)			
0CLI N/P B 2 x 2 2 x 2 Ti-Pc Multi FS Co	SAMPL	So	0.25		511.7 (2.4)	574.9 (2.6)	634,0 (3.0)	692.1 (3.0)					·
			0.39	462.9 (2.5)	522.9 (2.8)	585.0 (3.0)	644.0 (3.4)	702.0 (3.7)					
			0.64	475.1 (3.2)	534.8	596.3 (3.7)	653.7						
			ы	485.6 (4.0)	545.3 (4.4)	605.3							. 1
		emperature		20 <sub>0</sub> C	25°C	ე <sub>0</sub> 0	-25 <sub>0</sub> c	-50°C	-75°C	-100°C	-125°C	-150°C	-175°C

NOTE:

Standard Deviations Are Given in Parentheses

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AVERAGE I	
14.	
TABLE	

					OCLI N/P BSR 2 x 2 x Ti-Pd-Ag Multilay	10 a cm Si .025 cm Contacts er (blue)	OCLI N/P BSR 10 2 cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating		
					FS Cover 0.35 (300 )	0.35 μ Cu (.300 μm t IZE 16	t-on hick)		
Temperature	ស				So	Solar Constants	nts		
	H	0.64	0.39	0.25	0.174	0.128	0.086	0.063	0.04
20 <sub>0</sub> C	142.9 (3.3)	91.5 (2.5)	56.4 (1.8)						
25°C	147.2 (3.1)	94.1 (2.3)	55.7 (1.8)	35.9					
≎ <sub>0</sub> 0	148.8	93.7 (2.1)	55.9 (1.6)	35.8 (.9)					
-25°C		92.3	55.2 (1.7)	35.4	24.6 (.6)	18.1			
ე <sub>ი</sub> 05-			54.6 (1.6)	34.7	24.1	17.9	12.5	9.4 (.5)	
-75 <sub>0</sub> c					23.5	17.5	12.2	9.2 (.5)	6.5
-100°C			•		22.8 (.9)	16.9	11.8	8.9	6.4
-125°C						$\frac{16.3}{(1.0)}$	11.4	8.6	6.2 (.2)
-150 <sup>0</sup> C							11.0	8.4	6.2 (.1)
-175°C NOTE: SI	tandard De	175°C NOTE: Standard Doviations Are Given in Descrit.	,		-				6.2 (.1)

NOTE: Standard Deviations Are Given in Parentheses

(mV)	
<b>&gt;</b>	OIII
AVERAGE	
15.	
TABLE	

			0.063				586.2
			0.086				596.0
con 15 Lines Coating on ck)			0.128			548 (6.)	009
OCLI N/P BSR 10 ß cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating FS Cover 0.35 µ Cut-on (.300 µm thick)	2E 16	Solar Constants	0.174			543.4 (5.8)	598.25 (6 9)
OCLI N/P BSR 1 2 x 2 x . Ti-Pd-Ag Multilaye FS Cover	SAMPLE SIZE 16	Solar	0.25	433.5 (4.7)	494.6	547.3 (3.9)	599.8
			0.39 384.0 (3.0)	441.0	498.0 (3.0)	550.4 (3.2)	599.6
			392.8 (2.4)	443.9 (2.3)	499.8 (2.5)	550.0 (4.3)	
			$\frac{1}{388.1}$ (3.0)	442.1	498.2 (4.6)		
		Temperature	2 <sub>0</sub> 05	25°C	၁ <sub>၀</sub> ၀	-25°C	-50 <sub>0</sub> c

0.04

	574.7 (54.6)	601.9 (78.3)	627.9 (97.6)	645 (112.1)	658.3 (119.4)	
586.2 (25.5)	632.0 (16.4)	680.1 (39.2)	722.3 (53.6)	758 (87.6)		
596.0	654 (11.0)	703.6 (13.6)	756.2 (26.2)	801 (47.0)		
(6.)	656 (8)	711 (9)	766 (11)			
598.25 (6.9)	656.0 (6.2)	709.2 (7.7)				eses
599.8		à				in Parenth
599.6 (5.3)						Standard Deviations Are Given in Parentheses
-50°C	-75°C	-100°C	-125°C	-150°C	-175°C	NOTE:

TABLE 16. AVERAGE MP (mW)

		0.04						3.76	3.88	3.91	4.03	4.3
		0.063					5.5	5.9	6.1	6.2 (.8)	6.4 (1.0)	
OCLI  N/P BSR 10 ß cm Silicon  2 x 2 x .025 cm  Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating FS Cover 0.35 µ Cut-on  FS Cover 0.35 µ Cut-on  SAMPLE SIZE 16  Solar Constants	0.086					7.4 (.4)	7.9	8.3	8.6	8.85 (1.1)		
	0.128				9.9	10.8	11.5	12.1	12.5			
	lar Constan	0.174				13.3	14.4	15.4	16.1			
	Sc	0.25		15.6	17.7 (.5)	19.4	20.8					
	0.39	21.6	24.6	27.8	30.4 (1.0)	32.8 (1.0)						
	0.64	35.9 (1.1)	41.8 (1.1)	46.8 (1.2)	50.8 (1.3)							
	á	H	55.5 (1.4)	65.1 (1.6)	74.1							
	emperature		ა <sub>0</sub> 09	25 <sub>0</sub> c	ე <sub>ი</sub> 0	-25 <sub>0</sub> c	-50°C	-75°C	-100°C	-125°C	-150°C	-175°C

NOTE: Standard Deviations Are Given in Parentheses

TABLE 17. AVERAGE EFFICIENCY (%)

		0.04					17.4	17.9	18.1	18.6	19.8
		0.063				16.2	17.2	17.8	18.2	18.8	
OCLI N/P BSR 10 Ω cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating FS Cover 0.35 μ Cut-on (.300 μm thick) SAMPLE SIZE 16 Solar Constants		0.086				15.9	17.1	17.9	18.5	19.0	
	Ñ	0.128			14.3	15.6	16.6	17.4	18.0		
	ar Constant	0.174			14.2	15.3	16.3	17.1			
	Sol	0.25	11.5	13.1	14.3	15.4					
		0.39	11.6	13.2	14.4	15.5					
		10.4	12.1	13.5	14.7						
		$\frac{1}{10.3}$	12.1	13.7							
	Temperature	2005	25°C	ე <sub>0</sub> 0	-25°C	ე <sub>0</sub> 05-	-75°C	-100 <sub>0</sub> c	-125°C	-150°C	-175°C

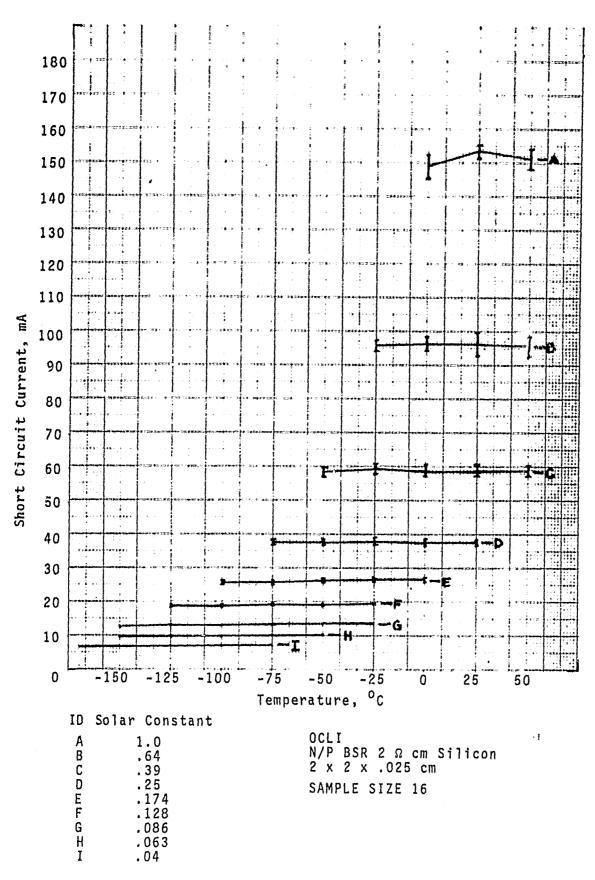
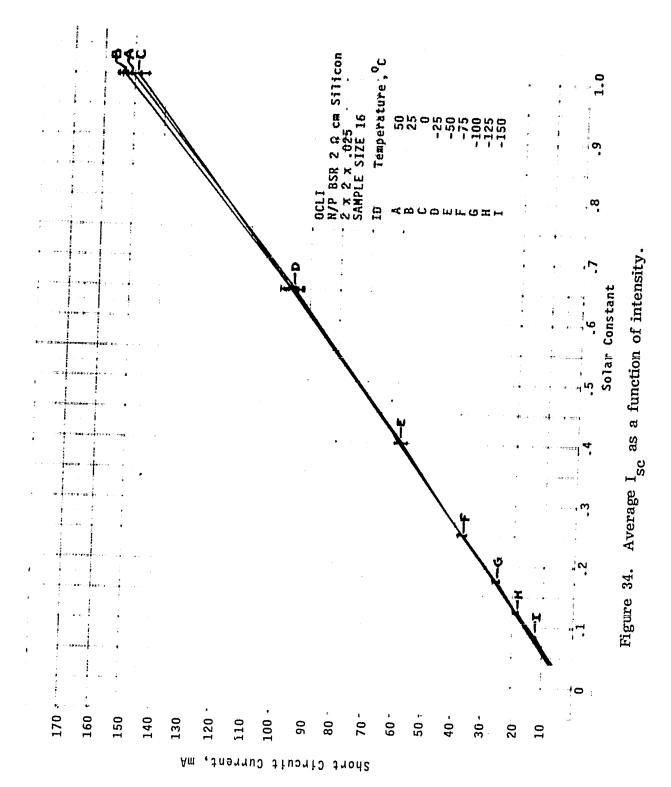


Figure 33. Average  $I_{sc}$  as a function of temperature.

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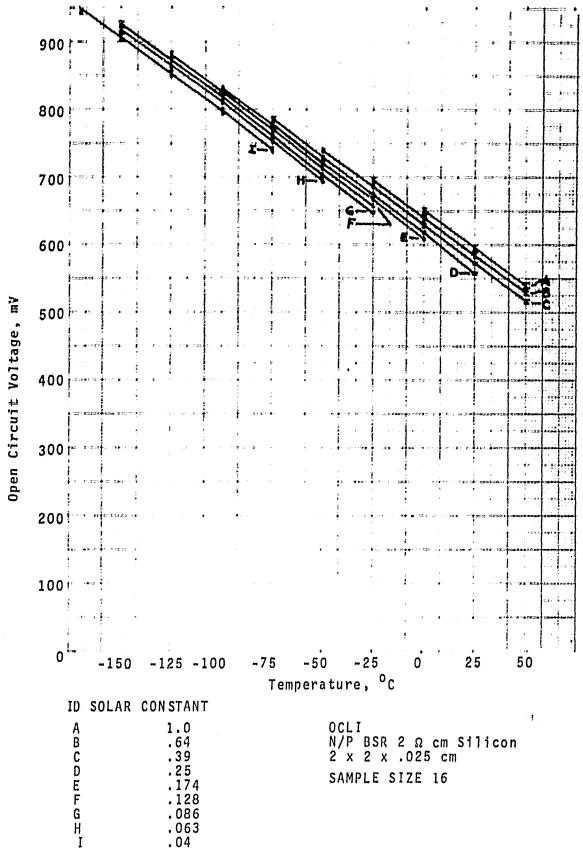


Figure 35. Average  $V_{\text{oc}}$  as a function of temperature.

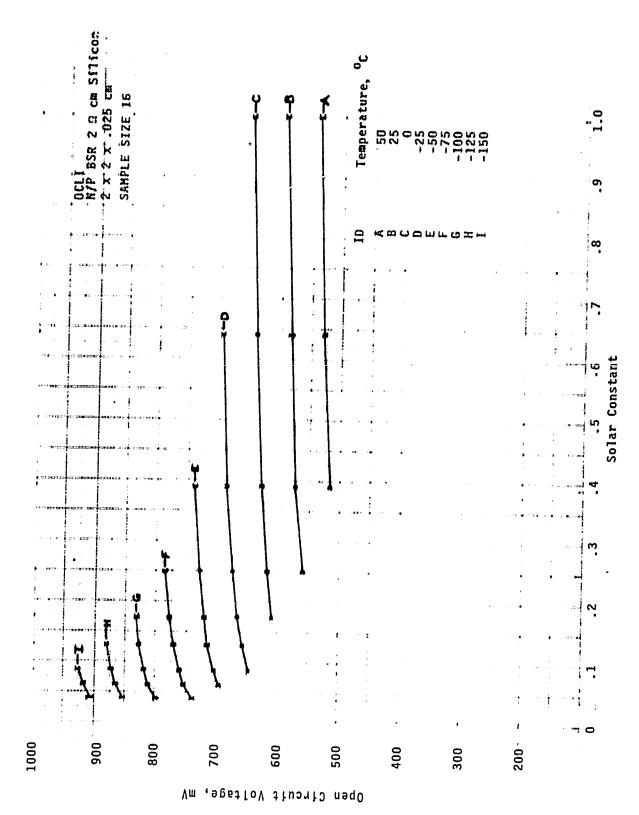


Figure 36. Average V as a function of intensity.

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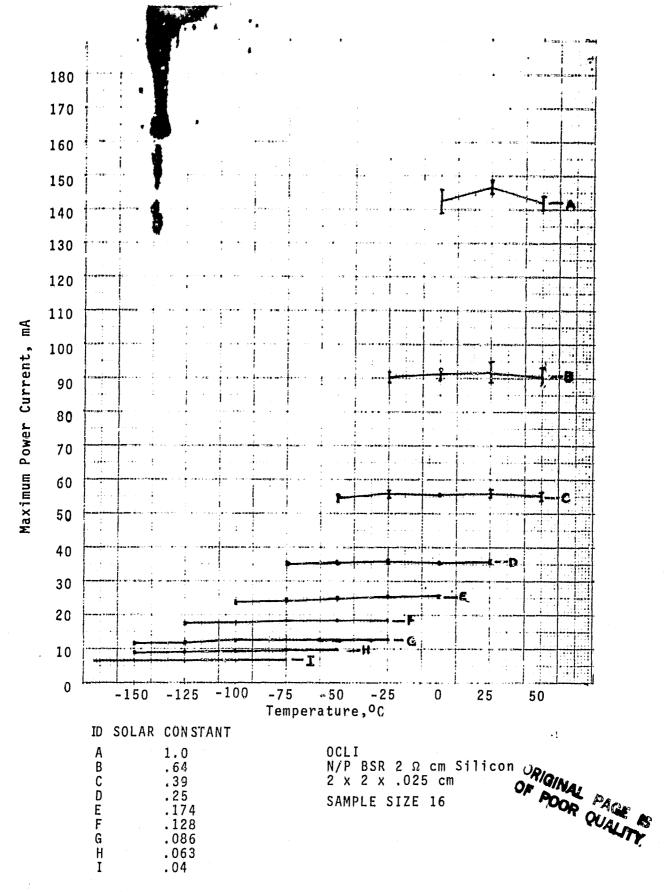
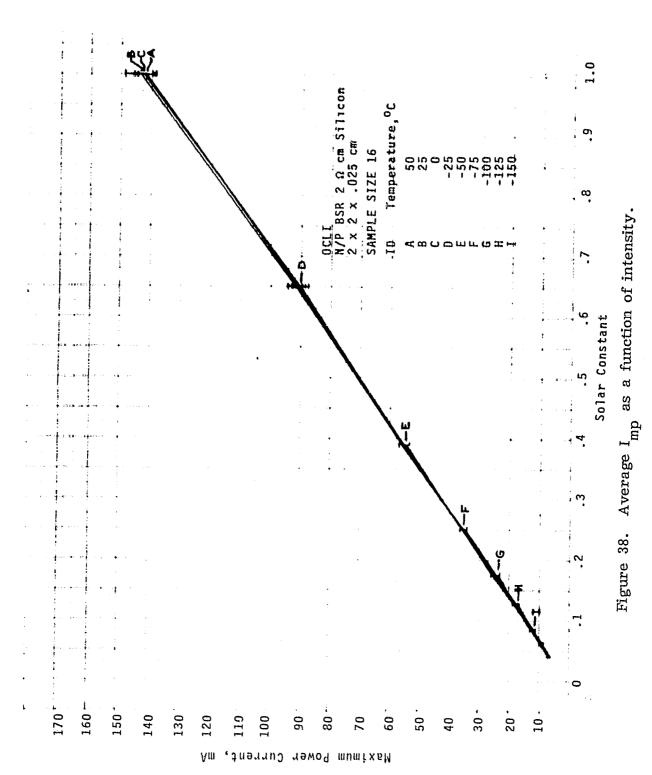


Figure 37. Average  $I_{\mathrm{mp}}$  as a function of temperature.



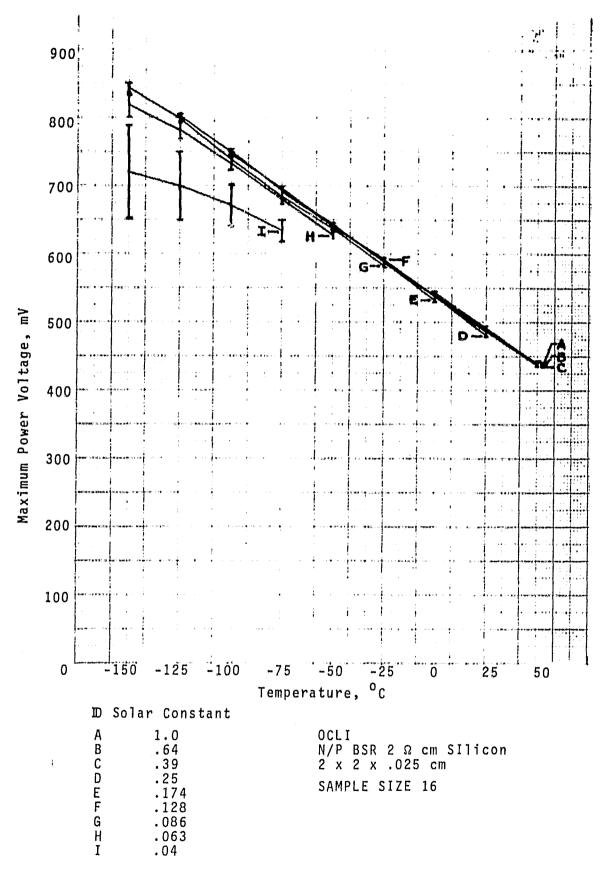


Figure 39. Average  $V_{\mathrm{mp}}$  as a function of temperature.

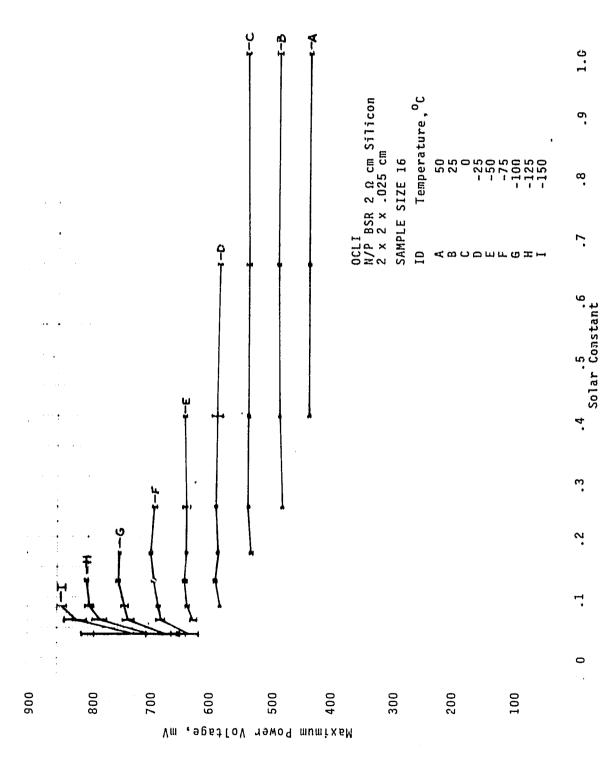


Figure 40. Average V as a function of intensity.

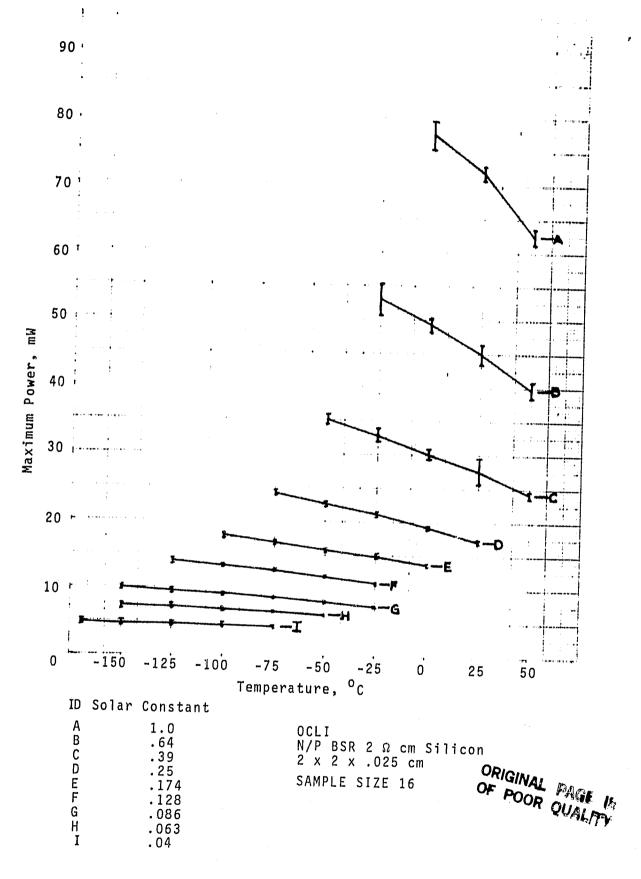


Figure 41. Average MP as a function of temperature.

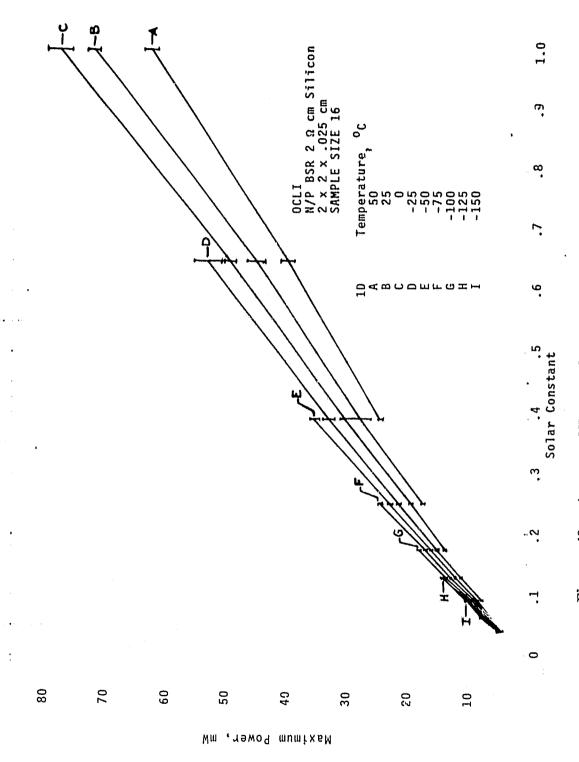


Figure 42. Average MP as a function of intensity.

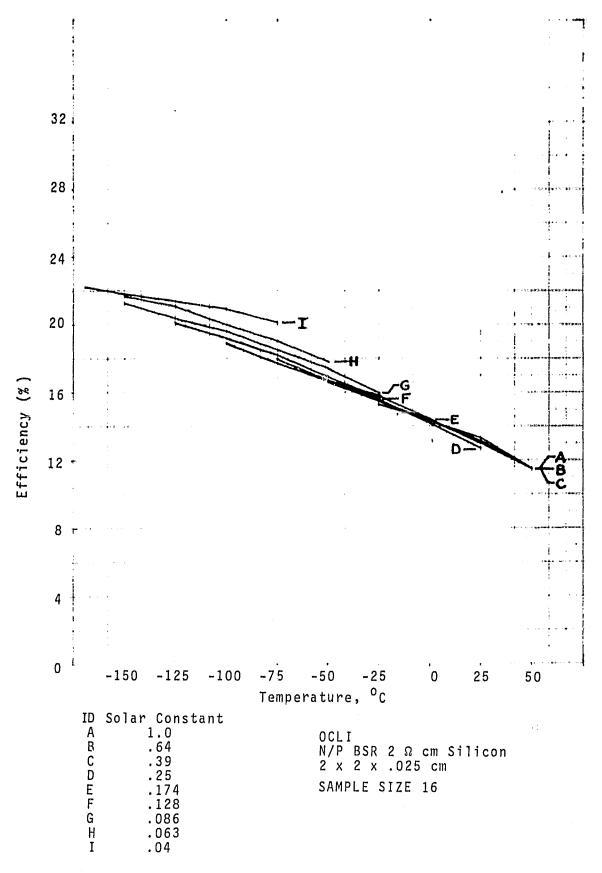
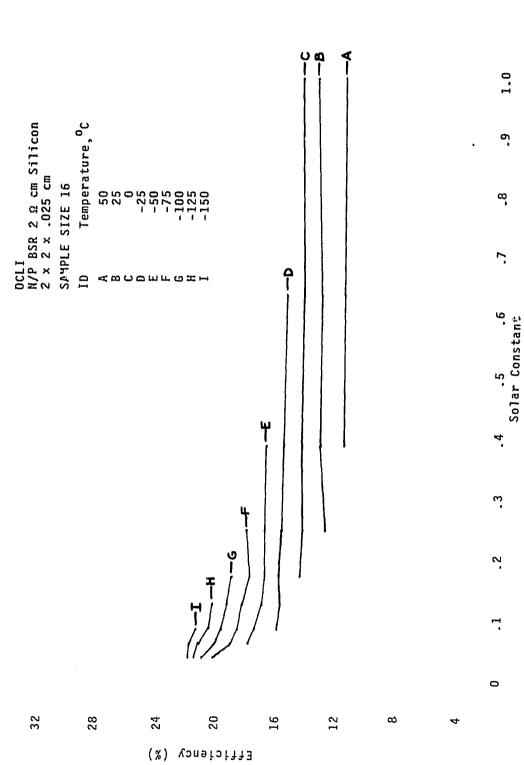


Figure 43. Average efficiency as a function of temperature.



Average efficiency as a function of intensity. Figure 44.

1.0

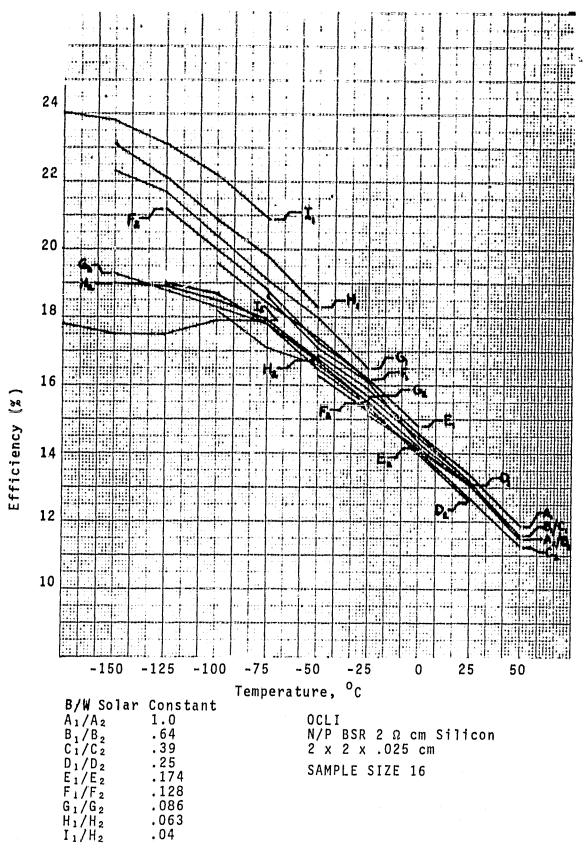


Figure 45. Efficiency of the best/worst cells as a function of temperature.

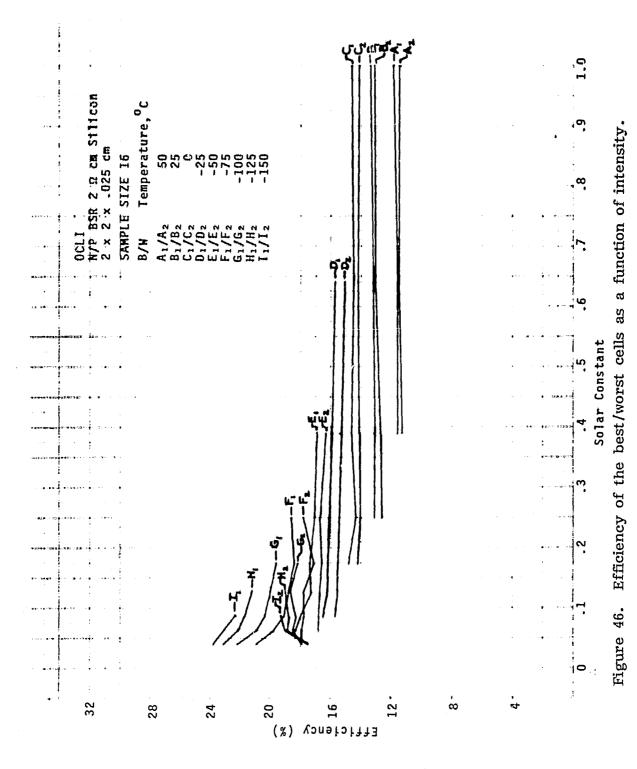


TABLE 18. AVERAGE  $I_{SC}$  (mA)

		20							7.2	7.2	7.0	7.0	6.8
	600						10.3	10.1	10.6	9.9	9.7		
	c c	200				13.7	13.6	13.3	13.1	12.9	12.7		
OCLI N/P BSR 2 Ω cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating FS Cover 0.35 u Cut-on (.300 μm thick)	ţ	ας: Θ	031.0				19.2	19.0	19.1	18.8	18.8		
OCLI N/P BSR 2 D cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Multilayer (blue) AR C FS Cover 0.35 u Cut-on (.300 um thick SAMPLE SIZE 16 SOlar Constants	สา รูปแระสมก	77.7			26.5	26.5	26.2	25.6	25.7				
OCLI N/P BS 2 x 2 Ti-Pd- Multil FS Cov	17388S	0 25 0 25	2		37.5	37.6 (1.0)	37.9	37.6	37.6				
		30	2	58.3	58.8 (1.6)	58.8 (1.6)	59.3	58.3					
		0 64	5	95.4	(3.8)	96.3 (2.0)	95.7						
		,	<b>-1</b> ]	151 (3.0)	153.3 (2.1)	149.1 (3.5)							
		amberarna	(	၁ <sub>၀</sub> 0%	52 <sub>0</sub> ເ	၁ <sub>၀</sub> ၀	-25 <sub>0</sub> c	ე <sub>ი</sub> 05-	-75°C	-190°c	-125°C	-150°C	-170°C

NOTE: Standard Deviations Are Given In Parentheses

TABLE 19. AVERAGE  $V_{OC}$  (mV)

	0.04					740.8	797.1	853.6	907.6	949.8 (7.5)
OCLI  N/P BSR 2 n cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating FS Cover 0.35 µ Cut-on (.300 µm thick) SAMPLE SIZE 16 Solar Constants	0.063				695.9	754.5	811.1	866.6	918.8 (2.9)	
	0.086			647.0	704.4 (2.0)	761.9	817.0	874.0 (4.1)	926.3 (3.8)	
	0.128			657.6 (1.8)	714.6 (2.6)	771.8 (2.8)	826.2 (3.2)	881.9 (2.7)		
	0.174		609.4 (1.9)	666.8 (2.4)	720.8	778.1 (2.7)	831.6			
	0.25	558.9	618.8 (2.3)	675.2 (2.5)	729.7 (2.7)	786.0 (3.4)				
	0.39 516.1 (2.1)	572.2 (2.1)	629.7	686.1 (2.6)	739.6					
	0.64 529.6 (2.9)	583.9	641.4	696.7 (3.5)						
	$\frac{1}{540.0}$ (3.7)	595.6	651.1 (4.1)							
Temperature	3 <sub>0</sub> 03	25°C	00	-25°C	ე <sub>0</sub> 09-	-75°C	-100 <sub>0</sub> c	-125°C	-150°C	-170°C

NOTE: Standard Deviations Are Given In Parentheses.

TABLE 20. AVERAGE I (mA)

		9.0						25	22	900	50	6.3
		0.063					7.7	9.5)	m m	9.5	0,5	
OCLI N/P BSR 2 ß cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating FS Cover 0.35 p Cut-on (.300 pm thick) SAMPLE SIZE 16 Solar Constant	0.086				F.2.7	12.7	12.6	(5.3)	96.5	11.7		
		9.128				18.3	18.2	18.2	17.7	17.4		
	Solar Constant	0,174			25.5	25.4	24.8	24.0	23.8			
OCLI N/P BSR 2 n cm 2 x 2 x .025 cm Ti-Pd-Ag Contac Multilayer (blu FS Cover 0.35 p (.300 pm	Solar	0.25		35.8	35.6	35.8	35.3	35.0				
		0.39	55.3	55.9	55.9 (1.2)	55.7	54.6 (1.0)					
•		0.64	90.5 (2.7)	91.8 (2.9)	91.3	90.3						
	re Pr	<b>~</b> I	142.1 (2.3)	146.8 (2.0)	142.5							
	Temperature		ე <sub>0</sub> 09	ວ <sub>ວ</sub> ເວ	ე <sub>0</sub> 0	ე <sub>0</sub> 92−	ე <sub>0</sub> 05−	J <sub>0</sub> 51-	-100 <mark>0</mark> c	-125°C	-150°C	-170°C

NOTE: Standard Deviations Are Given In Parentheses.

TABLE 21. AVERAGE V mp (mV)

		9.04						634.6	671.4	700.62 (50.6)	721.6 (69.0)	739.2 (72.8)
	0.063					627.5 (4.8)	681.9 (7.2)	733.3	782.8 (12.3)	819.8 (18.7)		
		0.036				583.3	637.9 (2.6)	684.4	739.4 (5.8)	799.1 (7.1)	843.3 (7.8)	
on 15 Lines 1 Coating on ck)		0.128				591.5	642.1	692.8	750.0 (3.9)	803.3		
OCLI N/P BSR 2 n cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Wultilayer (blue) AR Coating FS Cover 0.35 p Cut-on (.300 pm thick) SAMPLE SIZE 16	Solar Constants	0.174			533.0	587.3 (2.1)	639.2 (1.5)	696.9	747.4 (2.3)			
OCLI N/P BSR 2 n cm 2 x 2 x .025 cu Ti-Pd-Ag Contar Hultilayer (bl) FS Cover 0.35 (.300 i) SAMPLE SIZE 16	Solar C	0.25		481.5	537.9 (1.8)	590.7 (2.6)	639.2 (6.7)	691.8 (3.9)				
		0,39	437.1 (1.7)	486.4	538.6 (2.9)	589.9 (9.0)	642.6					
		0.54	438.8 (1.7)	489.3	539.8	587.3 (4.8)						
		1	439.1	490 (4.6)	543.3							
	Temperature		20 <sub>0</sub> c	25°C	ე <sub>ი</sub> ი	-25°C	ე <sub>ი</sub> 09-	-75°C	-100 <sub>0</sub> c	-125 <sup>0</sup> C	-150 <sub>0</sub> c	-170°C

NOTE: Standard Deviations Are Given In Parentheses

(mM)
MP
AVERAGE
22.
LABLE

		0.063					6.1	6.5	6.8	7.2 (.4)	7.4	
OCLI  N/P BSR 2 Ω cm Silicon  2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating FS Cover 0.35 µ Cut-on (.300 µm thick) SAMPLE SIZE 16 Solar Constants	0.086				7.4	8.1	8.6	9.1	9.5	9.9		
	0.128				10.8	11.7	12.6	13.3	13.9			
	0.174			13.6	14.9	15.7	16.7	17.8				
	So	0.25		17.2 (,3)	19.2 (1.3)	21.1	22.6	24.2 (.4)				
ŧ		0.39	24.2 (.5)	27.6 (1.9)	30.1	32.8	35.1					
		0.64	39.7	44.9	49.3 (1.6)	52.9 (2.4)						
	Ф	щI	62.4 (1.2)	71.8 (1.1)	77.4 (2.1)							
	Temperature		2 <sub>0</sub> 05	25°C	ე <sub>0</sub> 0	-25°C	-50°C	-75°C	-100°C	-125°C	-150°C	-170°C

0.04

4.5

4.6

4.7

NOTE: Standard Deviations Are Given in Parentheses.

-170°C

TABLE 23. AVERAGE EFFICIENCY (%)

		9.00						20.0	20.0	21.4	21.8	22.2
		0.063					17.8	19.0	20.0	21.1	21.7	
		0.086				ed to	27.4	ιο (δ) (**)	9 0) FI	26.4	21.3	
OCLI N/P BSR 2 % cm Silicon 2 x 2 x .025 cm Ti-Pd-Ag Contacts 3/15 Lines Multilayer (blue) AR Coating PS Cover 0.35 % Cut-on (.300 %m thick) SAMPLE SIZE 16 Solar Constants	0.128				Pro.	6.9	18.2	19.2	20.1			
	olar Constant	0.174			4.4	in w	1.94	17.71	တ် လ က			
OCLI N/P BSR 2 n cm 2 x 2 x .025 cm 71Pd-Ag Contac Multilayer (blu FS Cover 0.35 p (.300 p) SAMPLE SIZE 16	й	9.25		12.7	14.2	15.6	16.7	17.9				
		0.39	5.11	E 33. T	14.3	in in	16.6					
		0.64	11.5	13.0	14.2	15.3						
		mil	11.5	13.3	14.3							
	Temperature		J <sub>O</sub> 0S	25°C	ئ 0	-25°C	မ စ (၈ (၈	-75°C	20001-	-125°C	-150°c	-170°C

Two Terminal Silicon Solar Cell

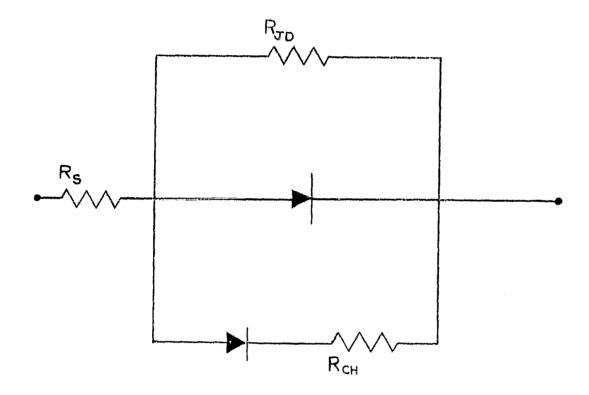


Figure 47. Simplified equivalent circuit of a silicon solar cell.

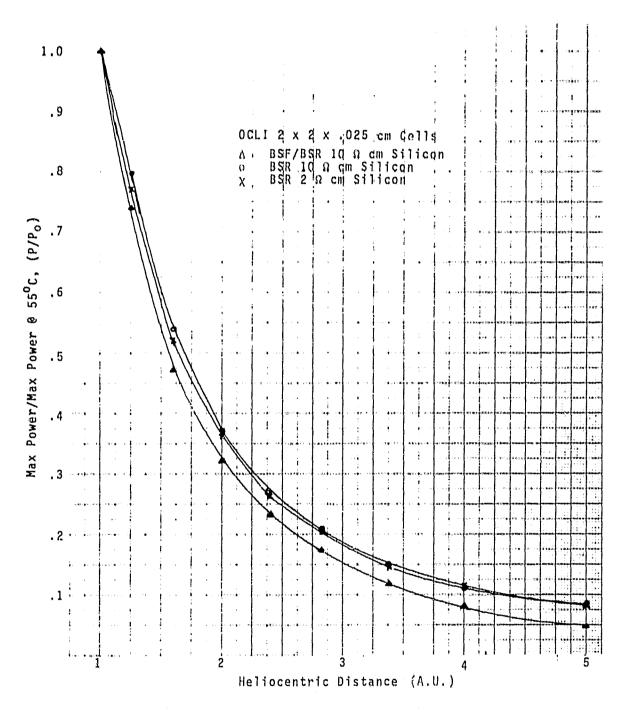


Figure 48.  $P/P_o$  as a function of heliocentric distance.

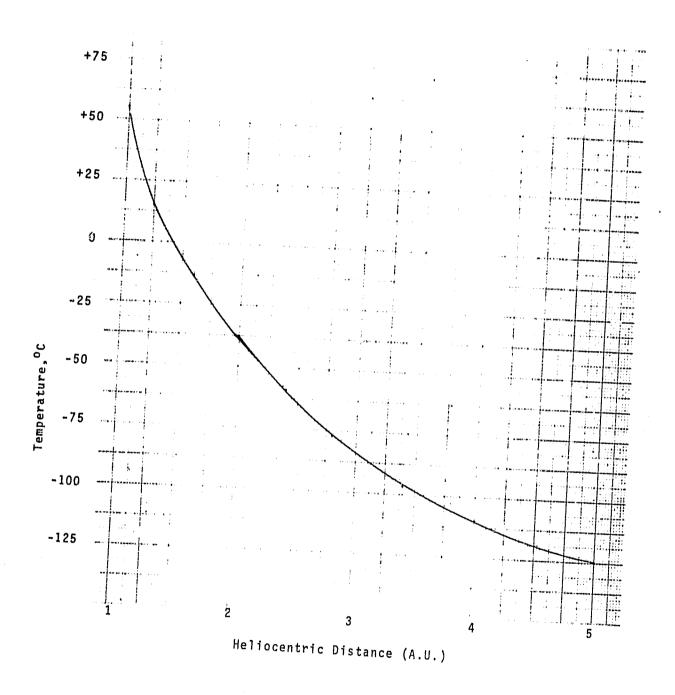


Figure 49. Solar array temperature versus AU.

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- 4. Bartels, F., Ho, J., and Kirkpatrick, A.: Silicon Solar Cell Development for Low Temperature and Low Illumination Intensity Operation. Vol. 1, Analysis Report. NAS2-5516, 1970.

## **GLOSSARY**

AU Astronomical Unit

AMO Air Mass Zero

BSF Back Surface Field

BSR Back Surface Reflector

I<sub>mp</sub> Maximum Power Current

I<sub>sc</sub> Short Circuit Current

LTLI Low Temperature and Low Intensity

MP Maximum Power

P/P<sub>o</sub> Ratio of Maximum Power to Maximum Power at 55°C

R<sub>CH</sub> Edge Channel Resistance

R<sub>JD</sub> Shunt Resistance

R<sub>S</sub> Series Resistance

SEPS Solar Electric Propulsion System

SC Solar Constant

UV Ultraviolet

## **APPROVAL**

## CHARACTERIZATION OF THREE TYPES OF SILICON SOLAR CELLS FOR SEPS DEEP SPACE MISSIONS

Volume I. Current-Voltage Characteristics of OCLI BSF/BSR 10 ohm-cm, BSR 10 ohm-cm, and BSR 2 ohm-cm Cells as a Function of Temperature and Intensity

By A. F. Whitaker, S. A. Little, C. F. Smith Jr., and V. A. Wooden

The information in this report has been reviewed for technical content. Review of any information concerning Department of Defense or nuclear energy activities or programs has been made by the MSFC Security Classification Officer. This report, in its entirety, has been determined to be unclassified.

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